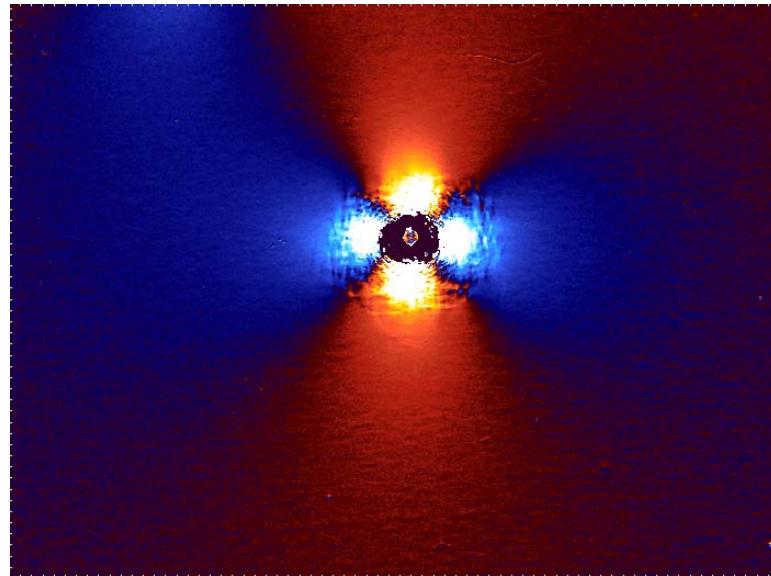


Direct Stress Of Windows

Integrated Window Inspection Technology (IWIT)



Jon R Lesniak
Feb. 29 2012

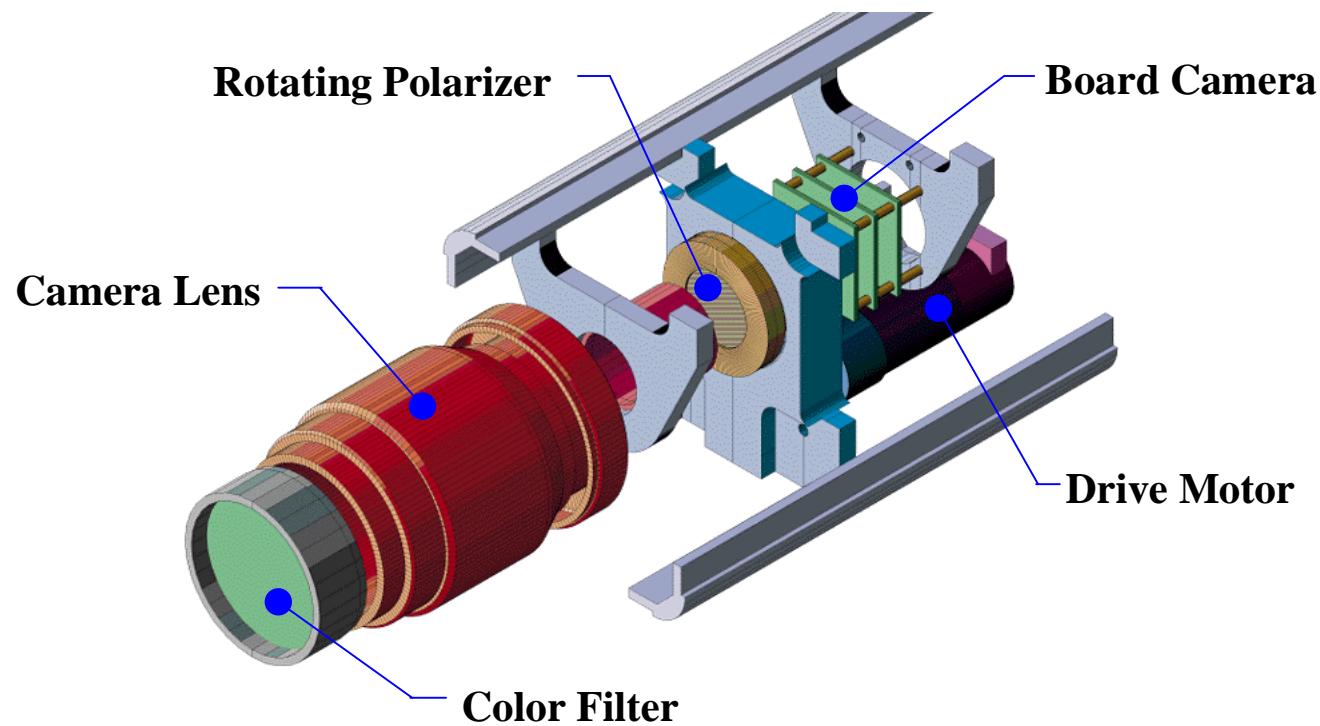
Stress Photonics



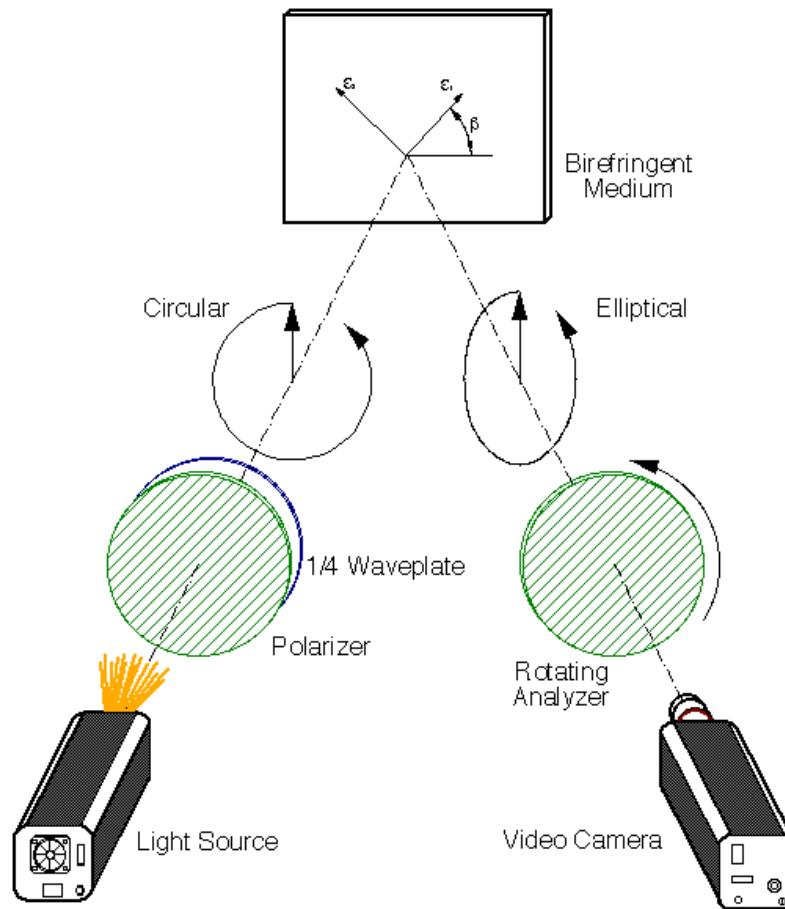
3002 Progress Road
Madison, Wisconsin 53716
Phone: (1) 608-224-1230 Fax: (1) 608-224-1233
email: info@stressphotonics.com
Web site: www.stressphotonics.com

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Photonics*

NASA LaRC Funded GFP 1000



GFP Fundamentals



**Stress
Photonics**

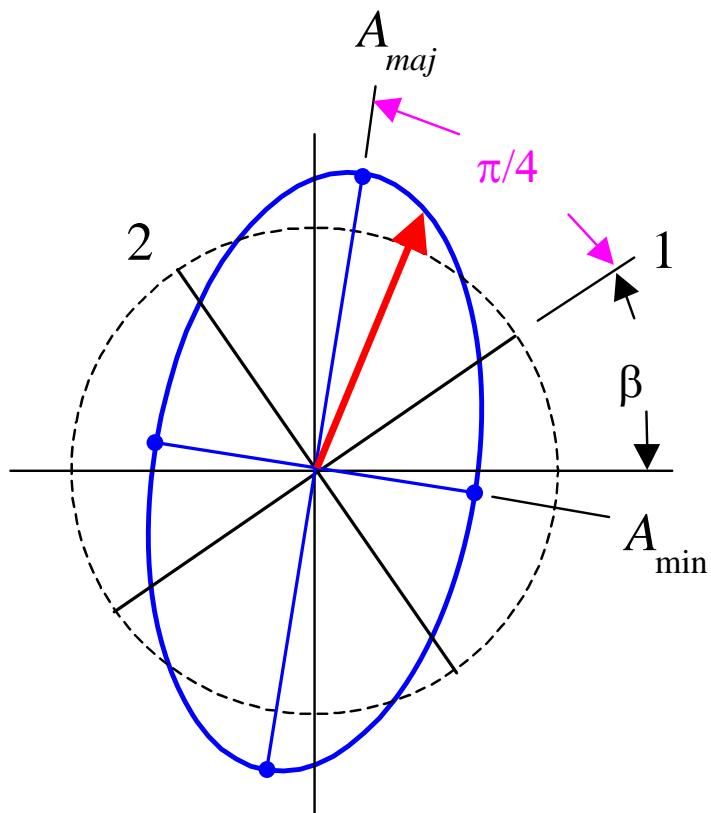
GFP1200c

General purpose lab tool



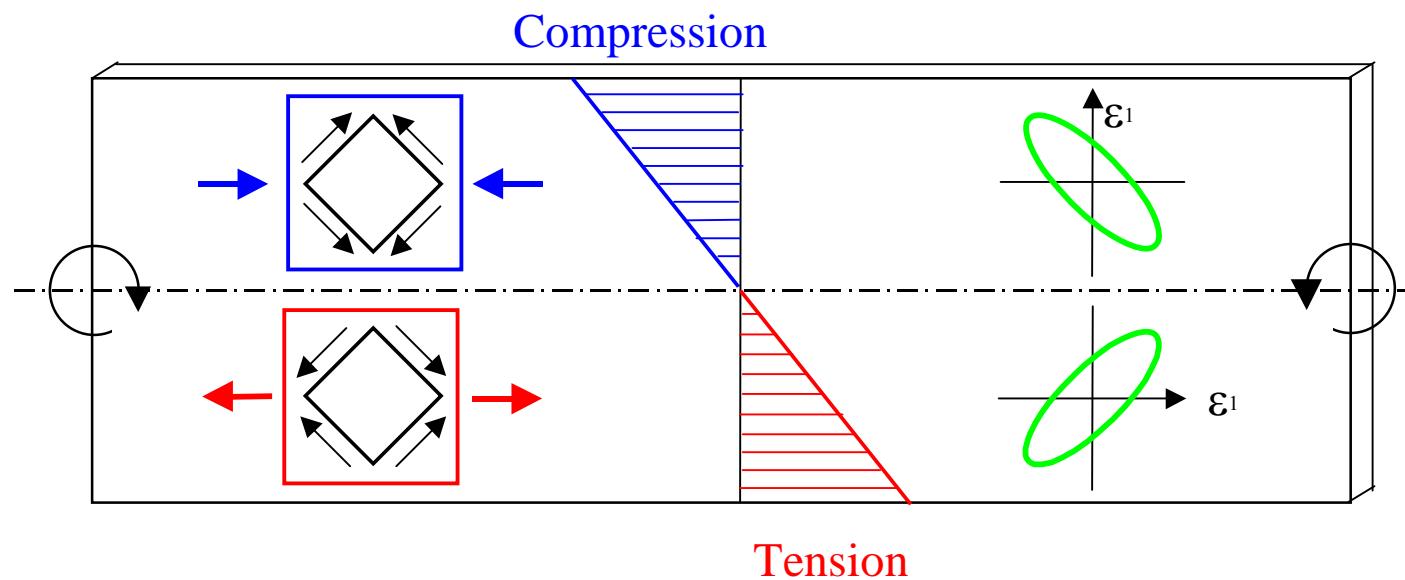
*Stress
Photonics*

Elliptically Polarized Light



$$A_{maj} = a \cos\left(\frac{\pi}{4} - \frac{\Delta}{2}\right) \cos\left(\eta t + \frac{\pi}{4} + \beta\right)$$
$$A_{min} = a \cos\left(\frac{\pi}{4} + \frac{\Delta}{2}\right) \sin\left(\eta t + \frac{\pi}{4} + \beta\right)$$

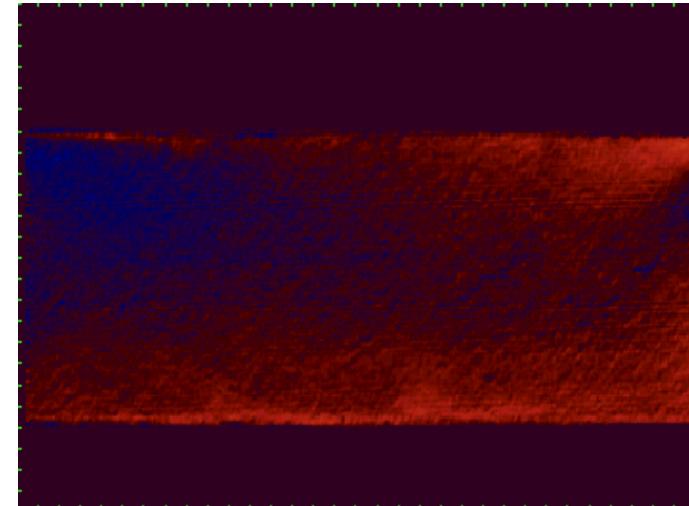
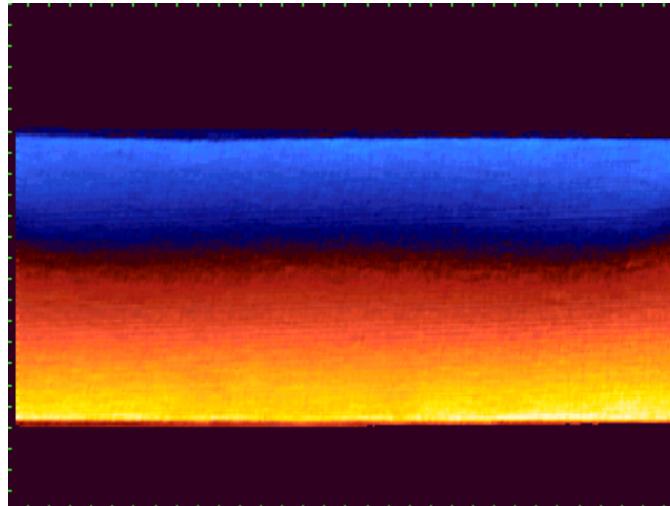
Beam in Bending



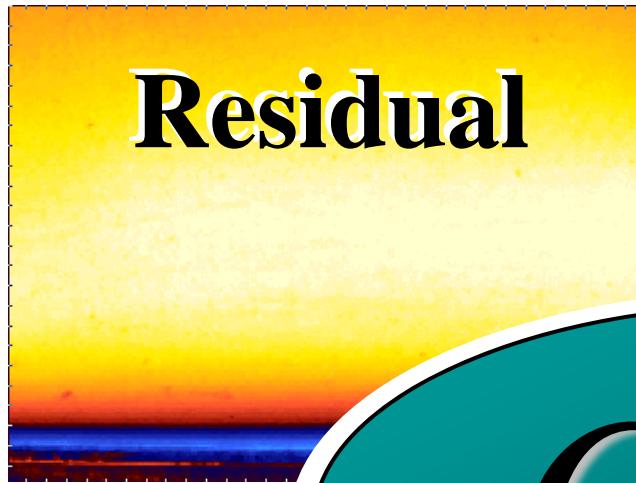
Shear Planes

$$\bar{I}_{\sin} \rightarrow \gamma_{45}$$

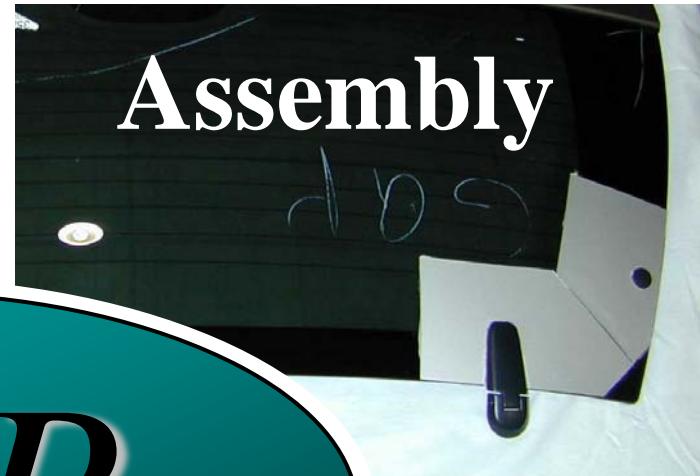
$$\bar{I}_{\cos} \rightarrow \gamma_0$$



Residual



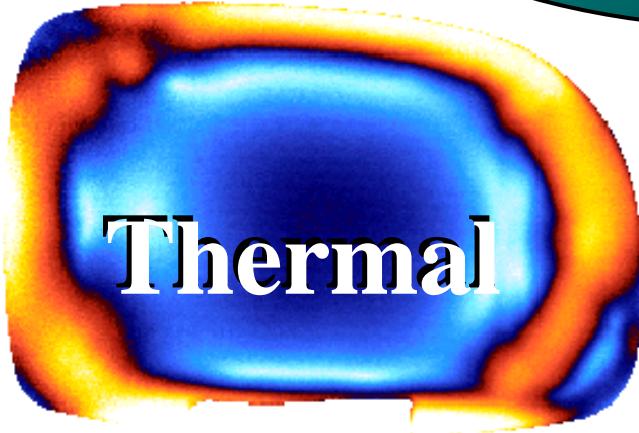
Assembly



GFP

Grey-Field Polariscopes

Thermal

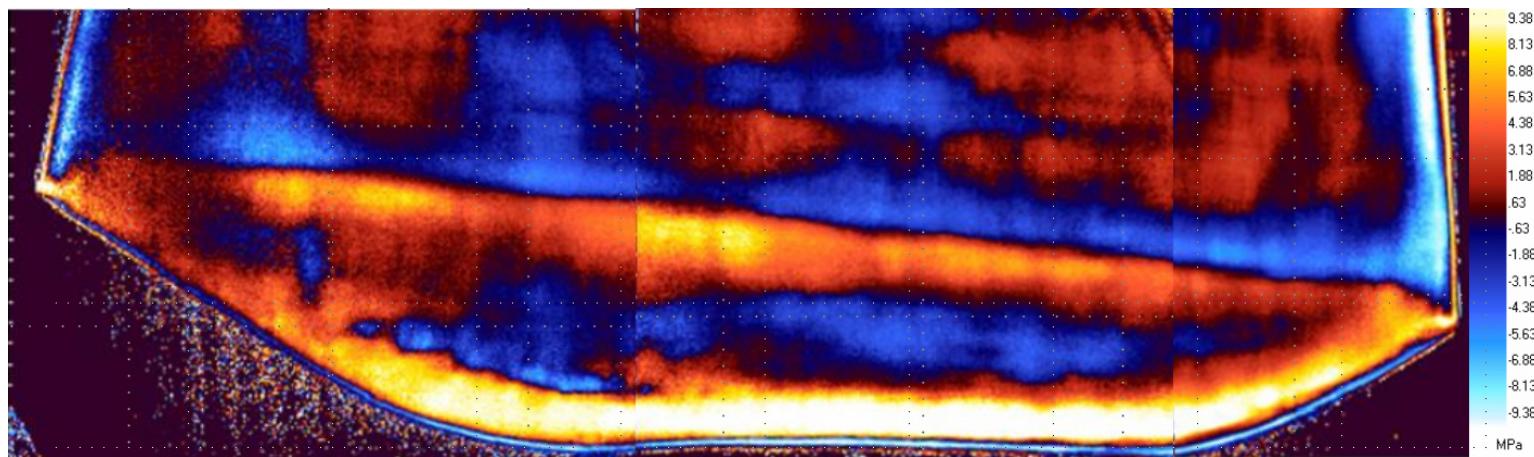


Installation

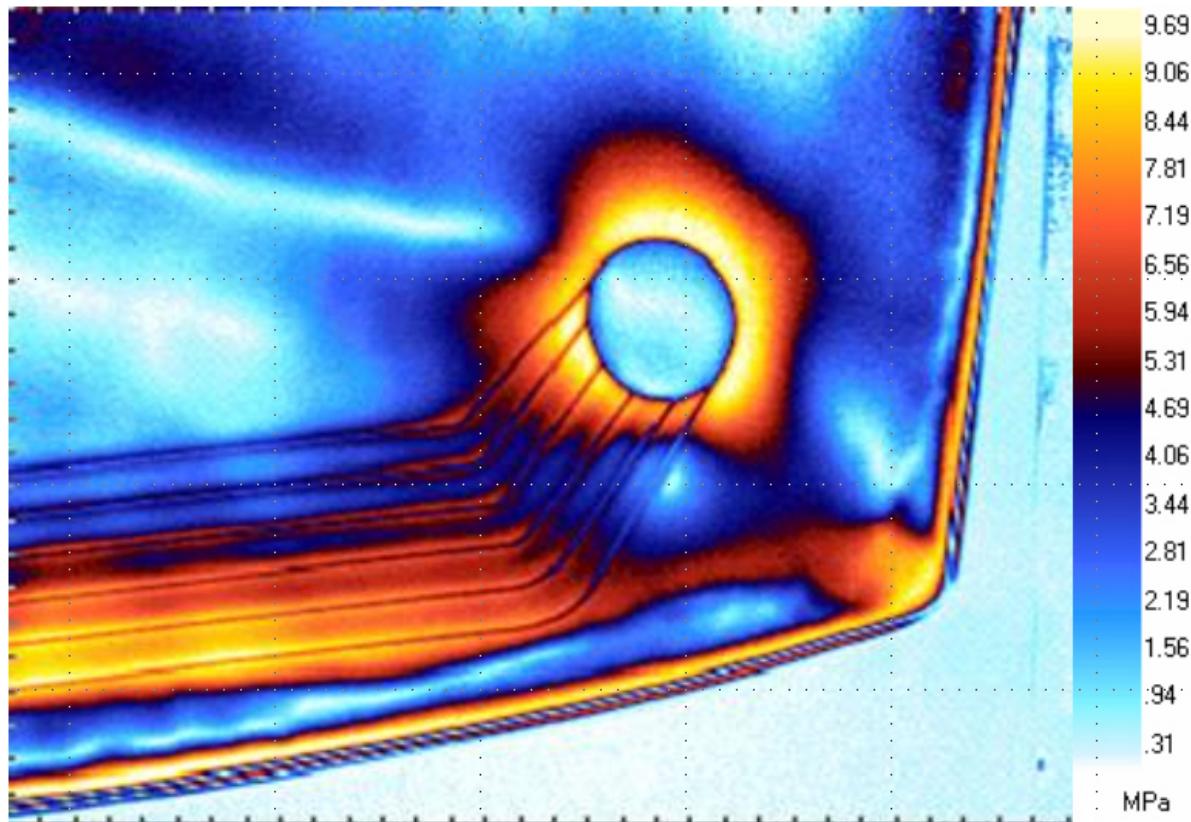


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Press form - Fold Line

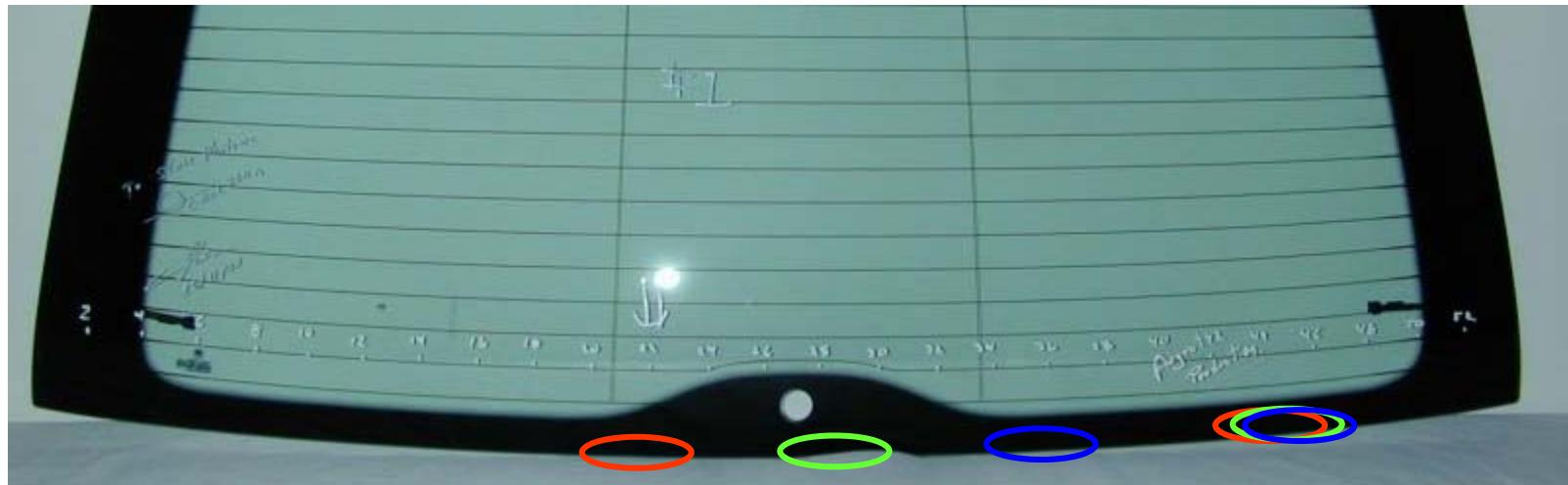


Effects of silver patterns

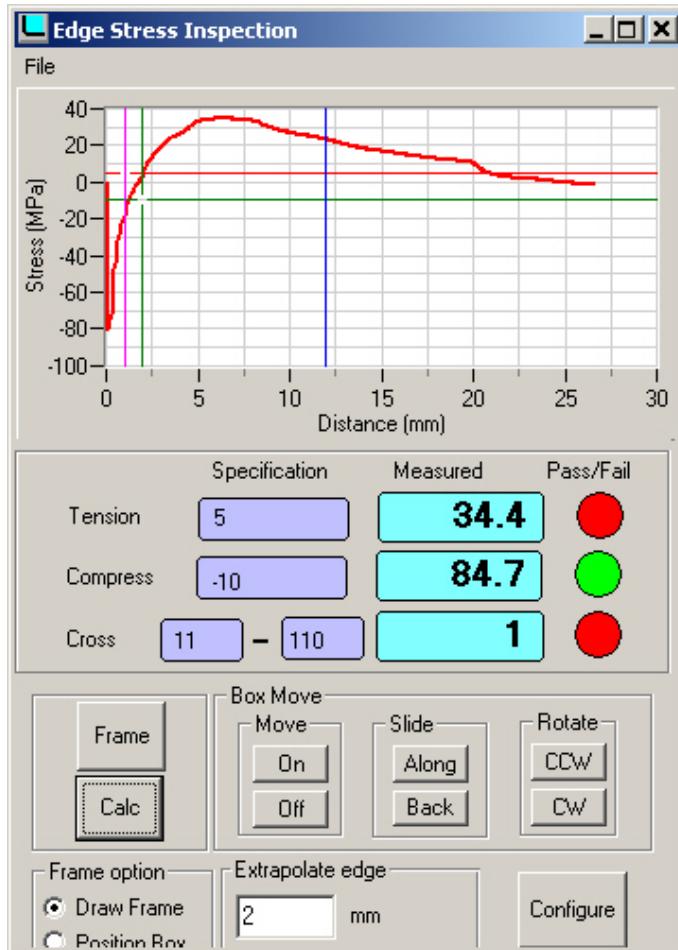
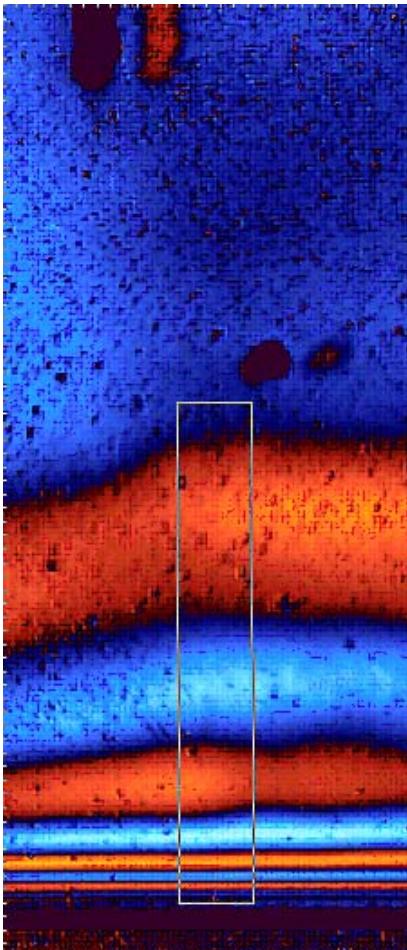


Flaw Locations

- August Production Hot Spots
- September Production Hot Spots
- Dec. '02 Production Hot Spots

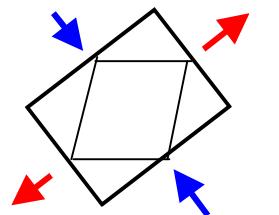


Defects

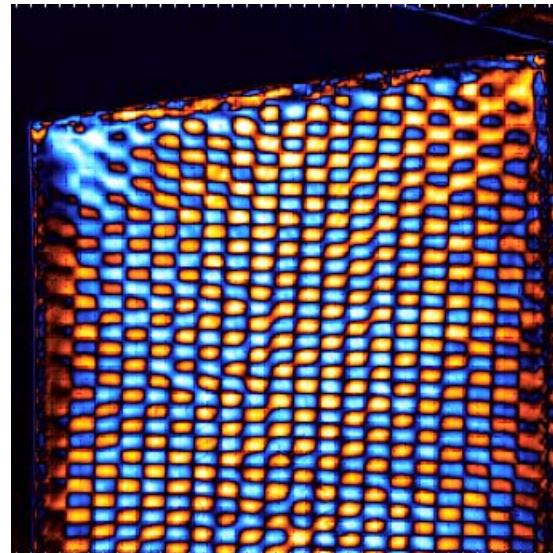
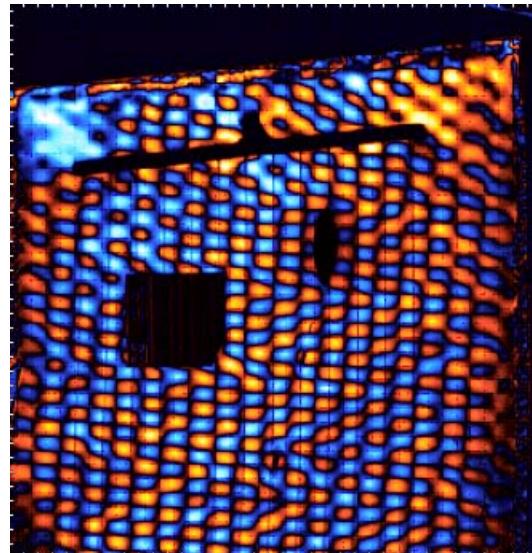


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Photonics*

Temper Patterns



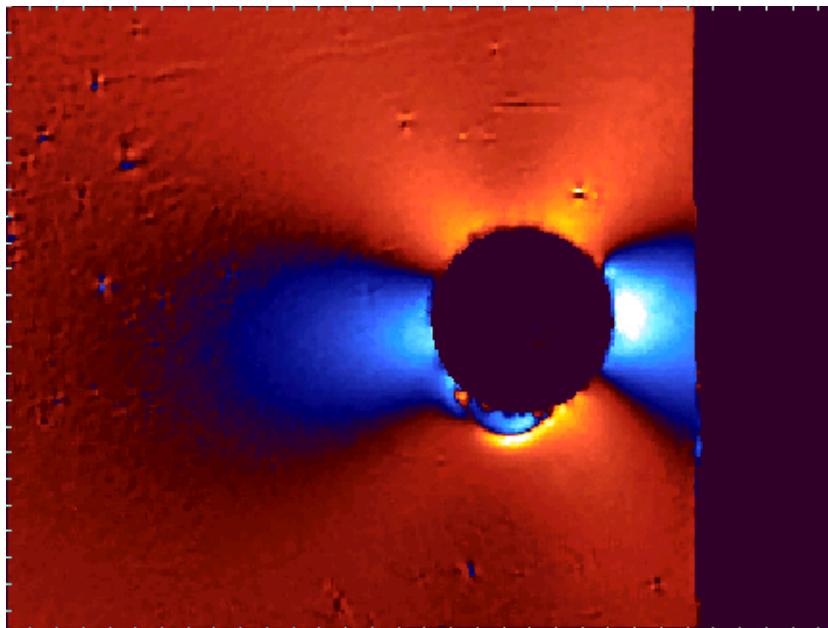
$\sigma_{45}-\sigma_{-45}$



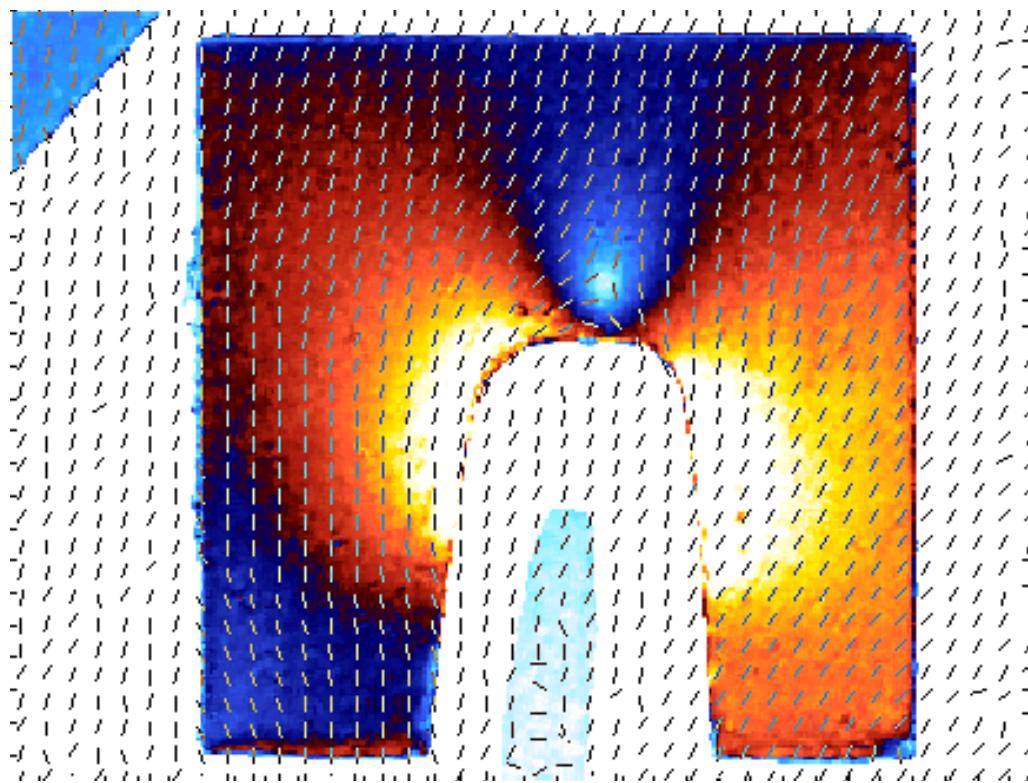
Reverse Assembly Strain



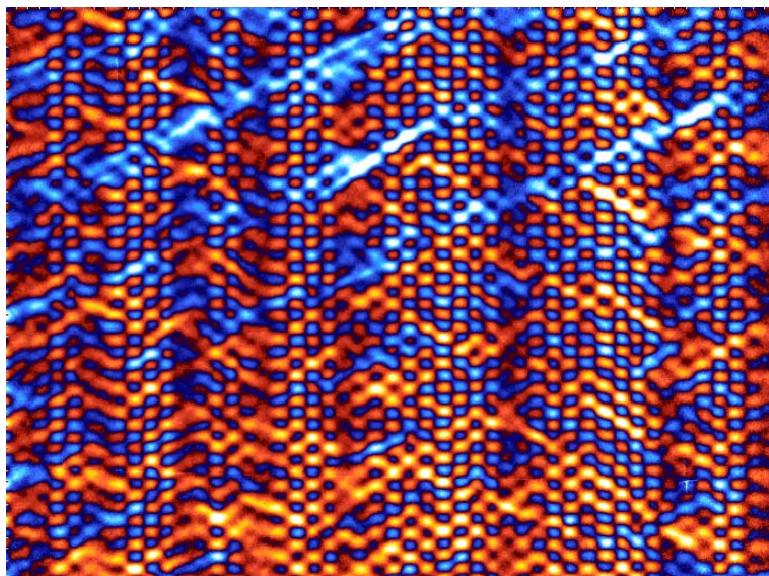
Stresses Around Button



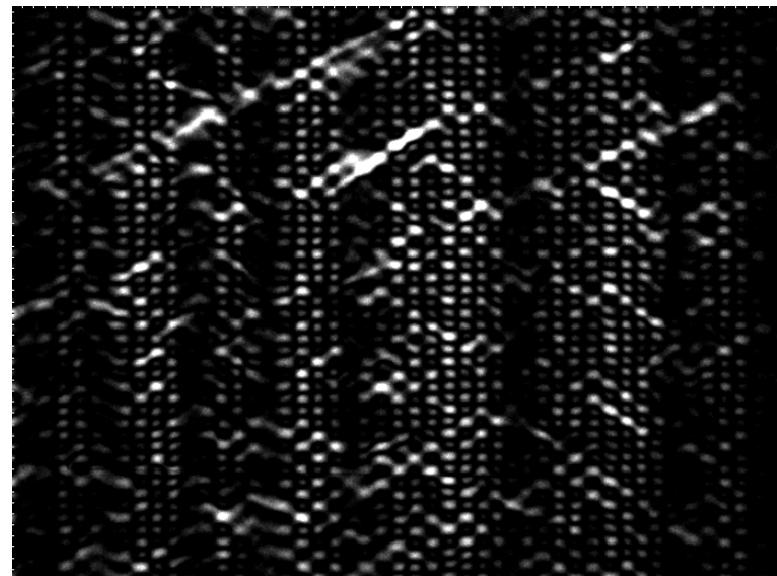
Hinge Assembly Stress



Predicting iridescence – online

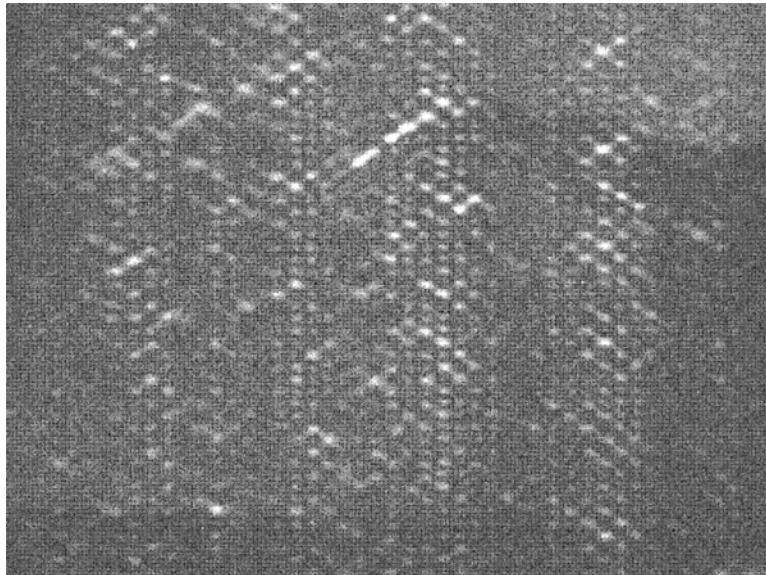


Stress Photonics GFP
Stress Map σ_{45}

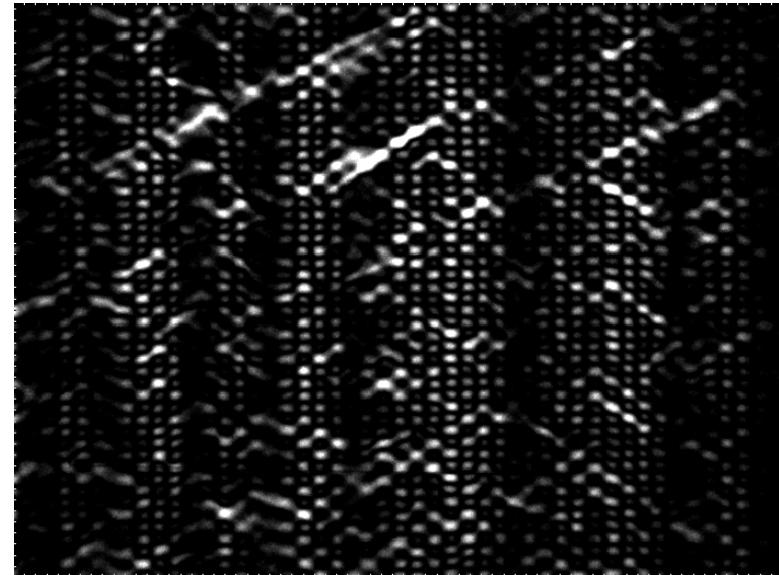


Predicted iridescence –
calculated from stress map

Iridescence prediction vs. actual



Actual Iridescence



Predicted iridescence

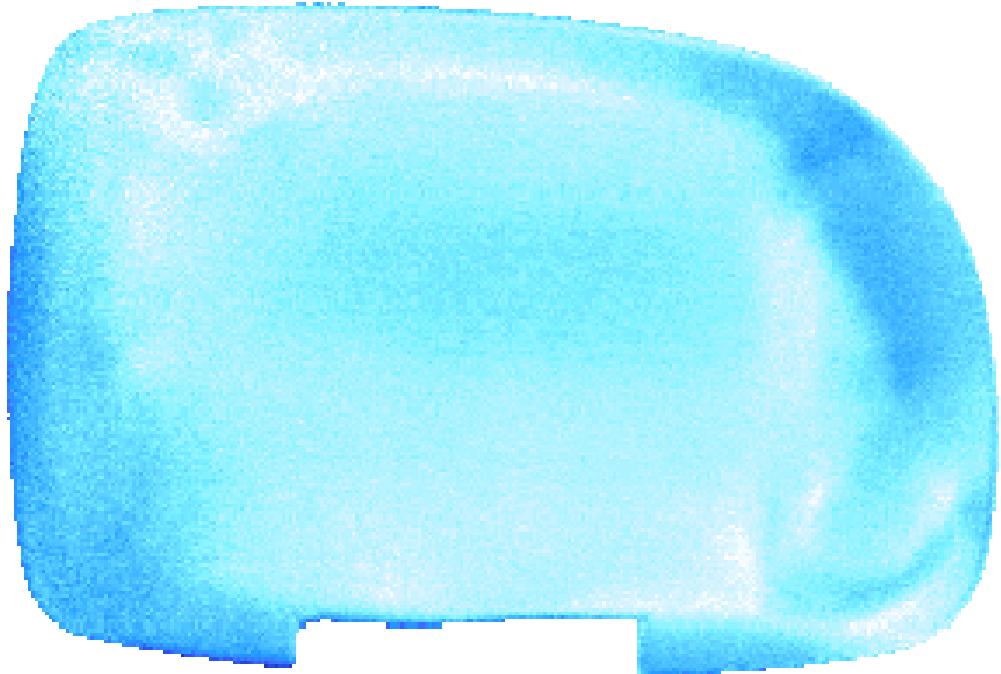
T=0



$\sigma_1 - \sigma_2$

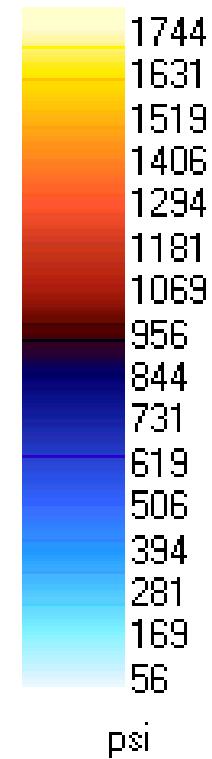
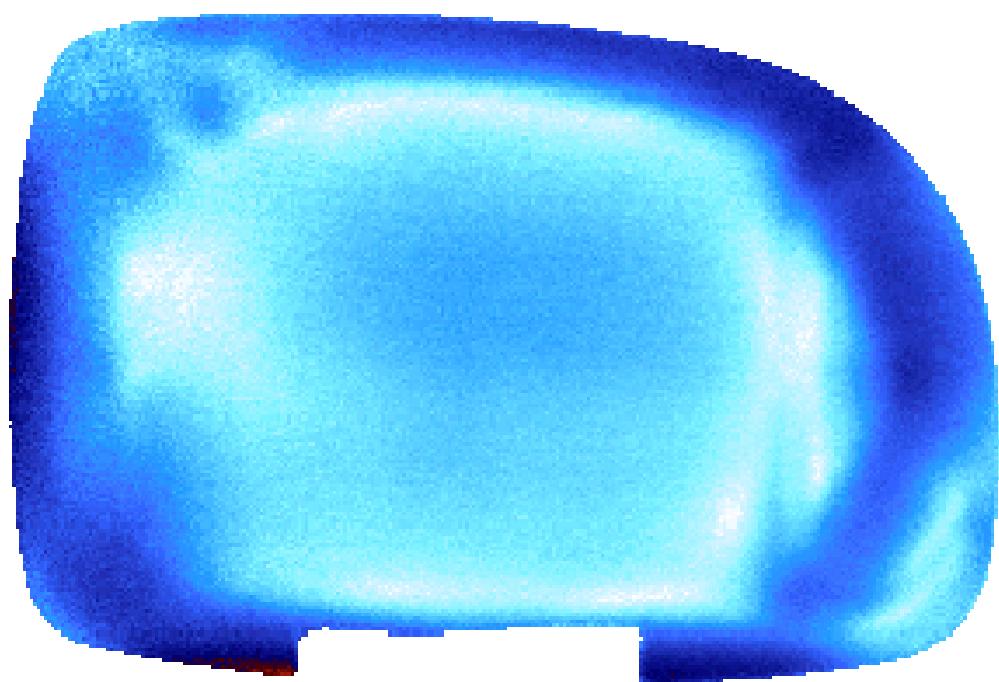
*Stress
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$T = 0^+$



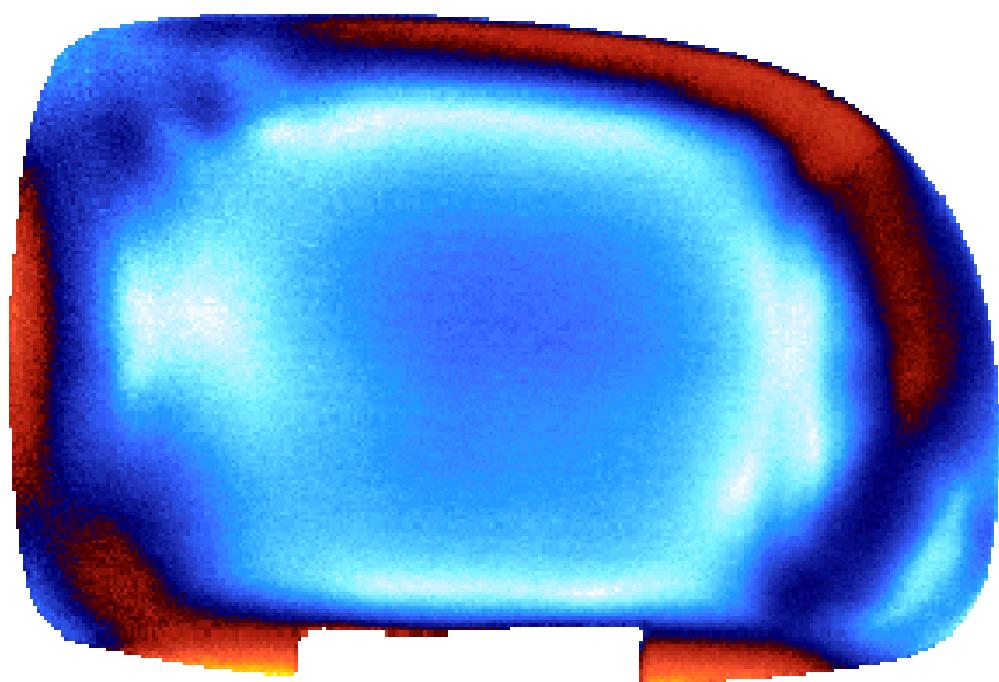
$\sigma_1 - \sigma_2$

T = 1 min.



$\sigma_1 - \sigma_2$

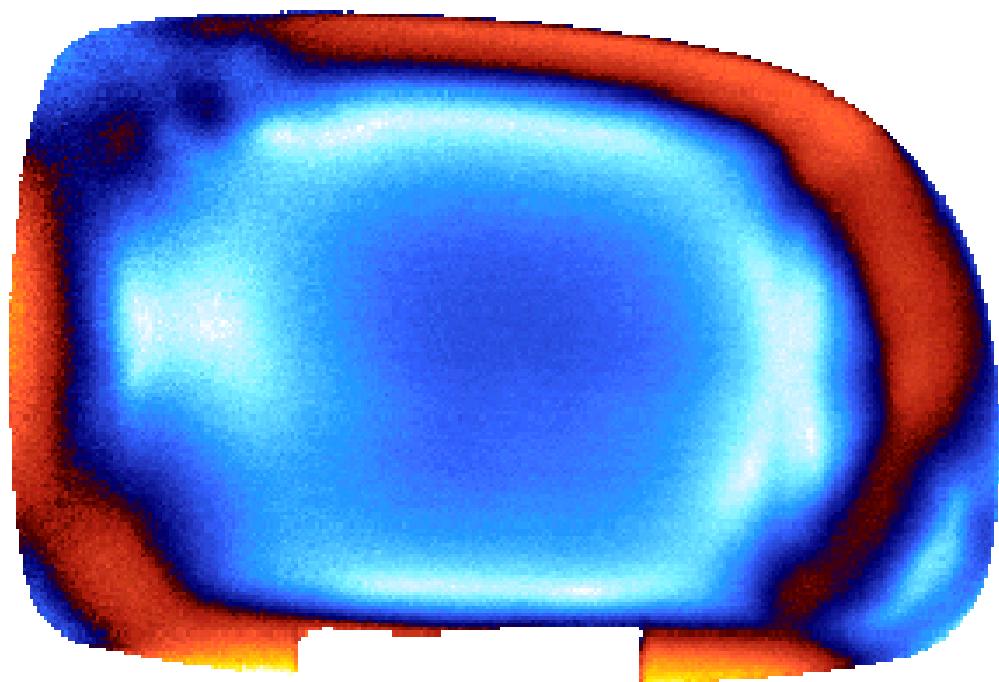
T = 2 min.



$\sigma_1 - \sigma_2$

*Stress
Photonics*

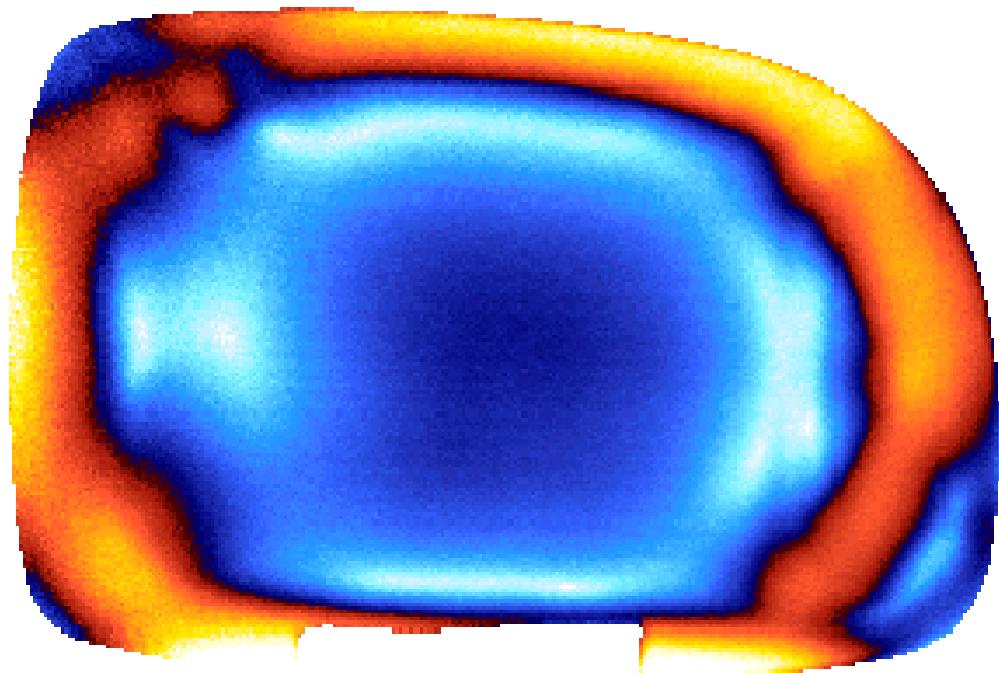
T = 3 min.



$\sigma_1 - \sigma_2$

*Stress
Photonics*

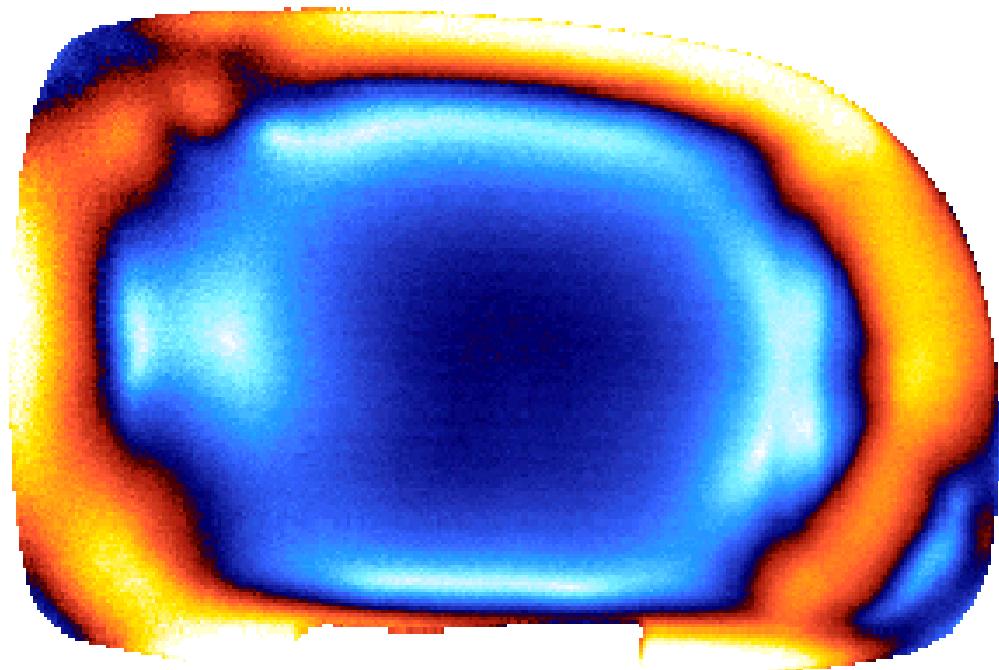
T = 4 min



$\sigma_1 - \sigma_2$

*Stress
Photonics*

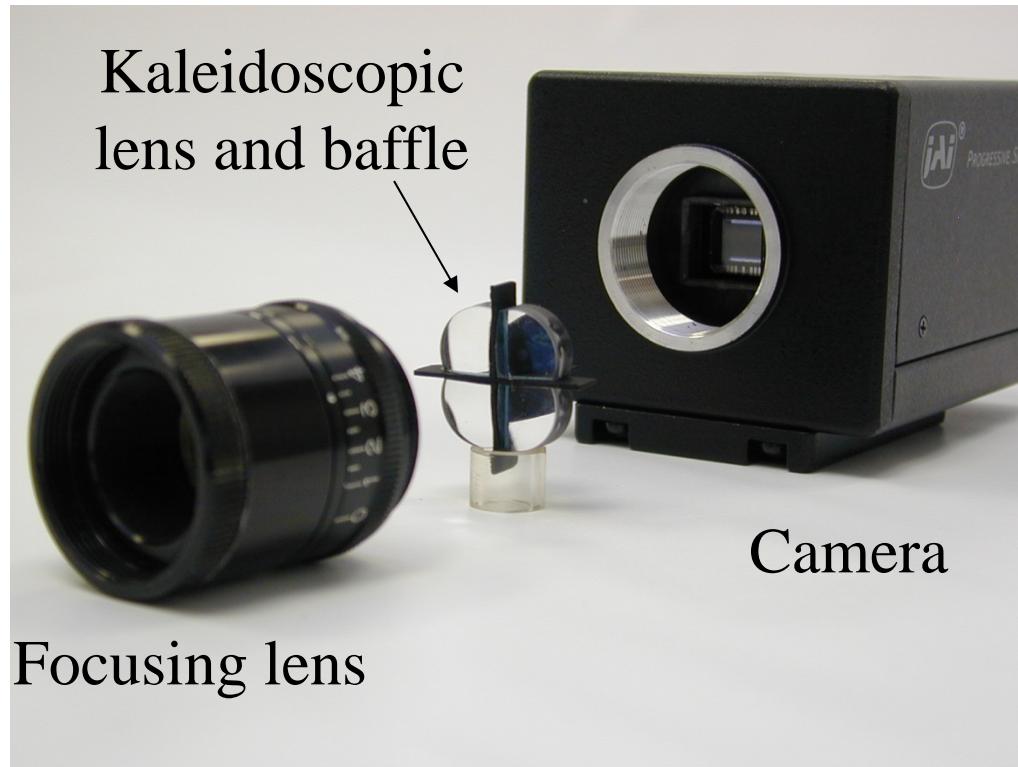
T = 5 min



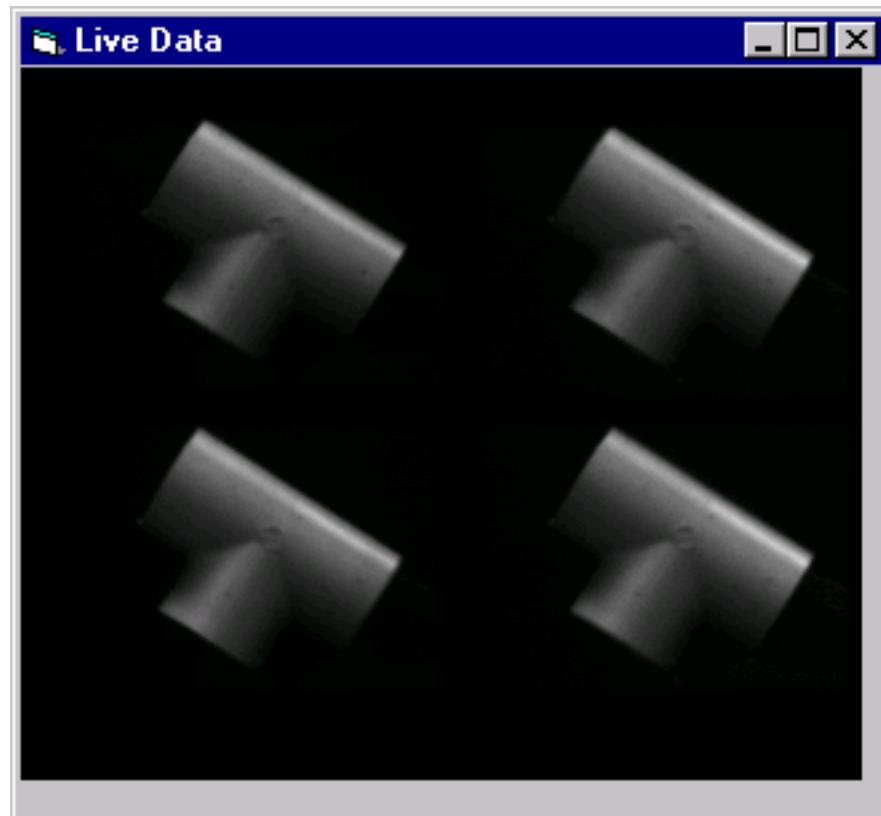
$\sigma_1 - \sigma_2$

*Stress
Photonics*

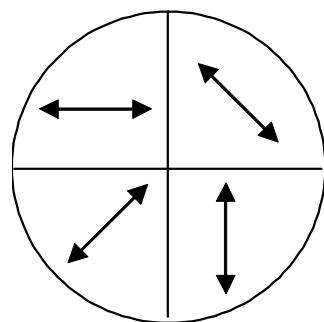
Poleidoscope construction



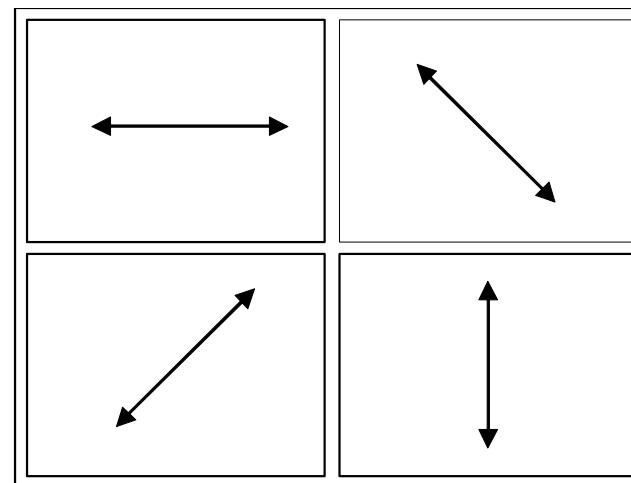
Video Image



Simple Polarizer Set



Filters on lens



Result on Detector

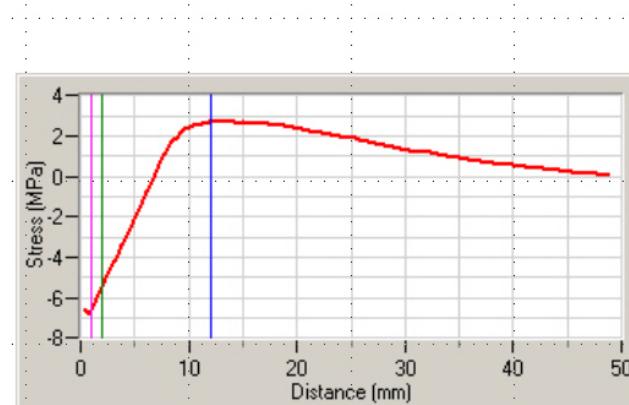
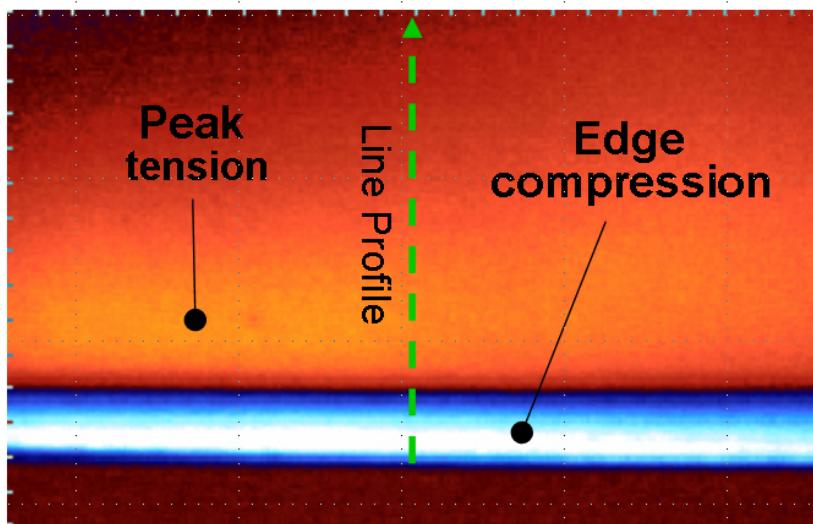
Glass Inspection



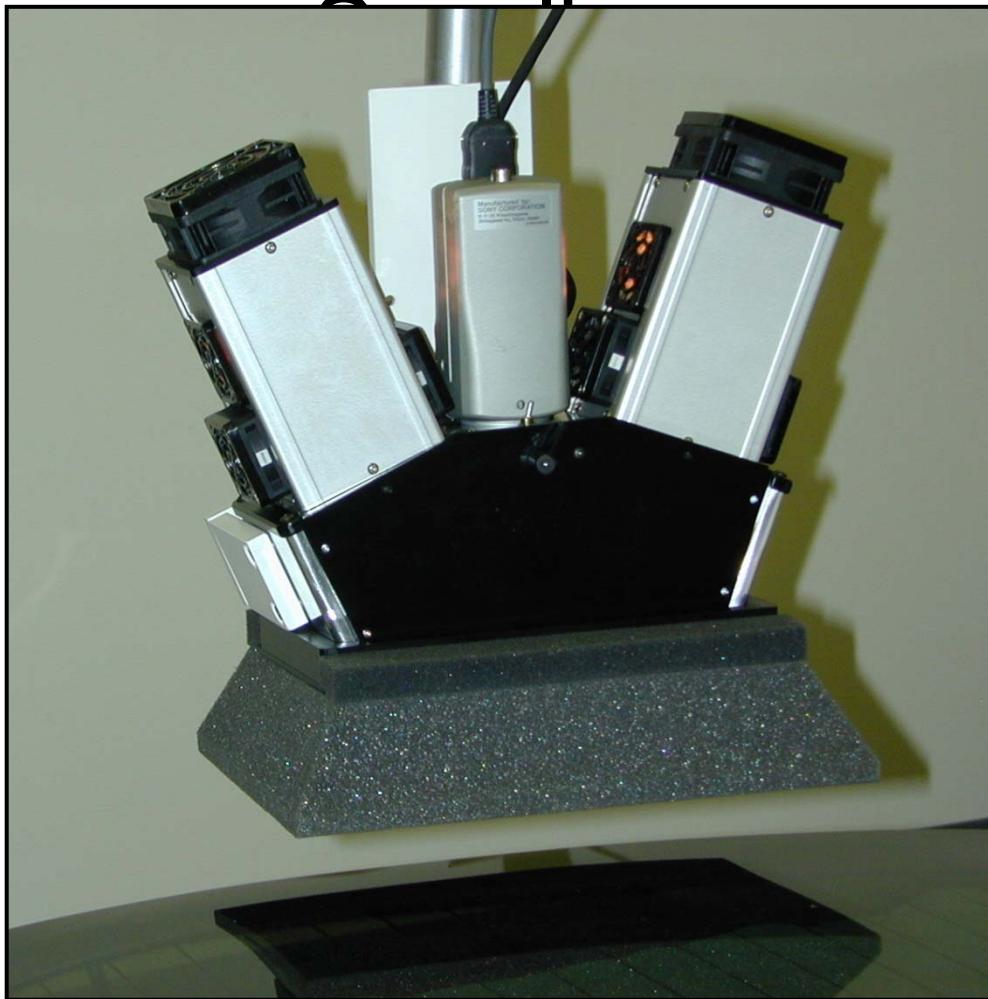
Edge Master

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Edge Stress



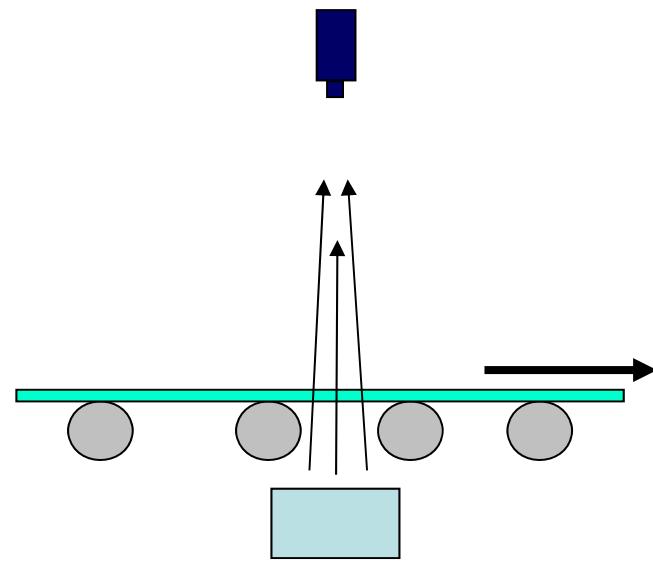
Quality Control – Responsible



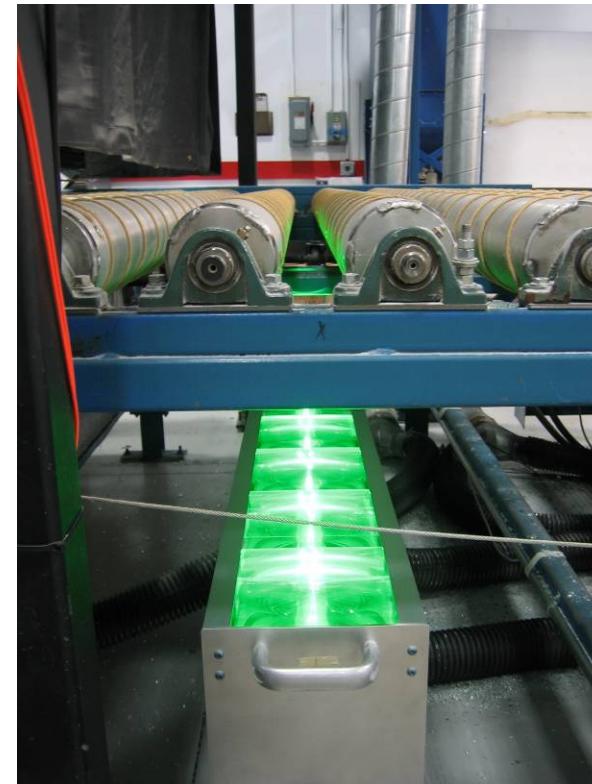
*Stress
Photonics*

Transmission Illuminator

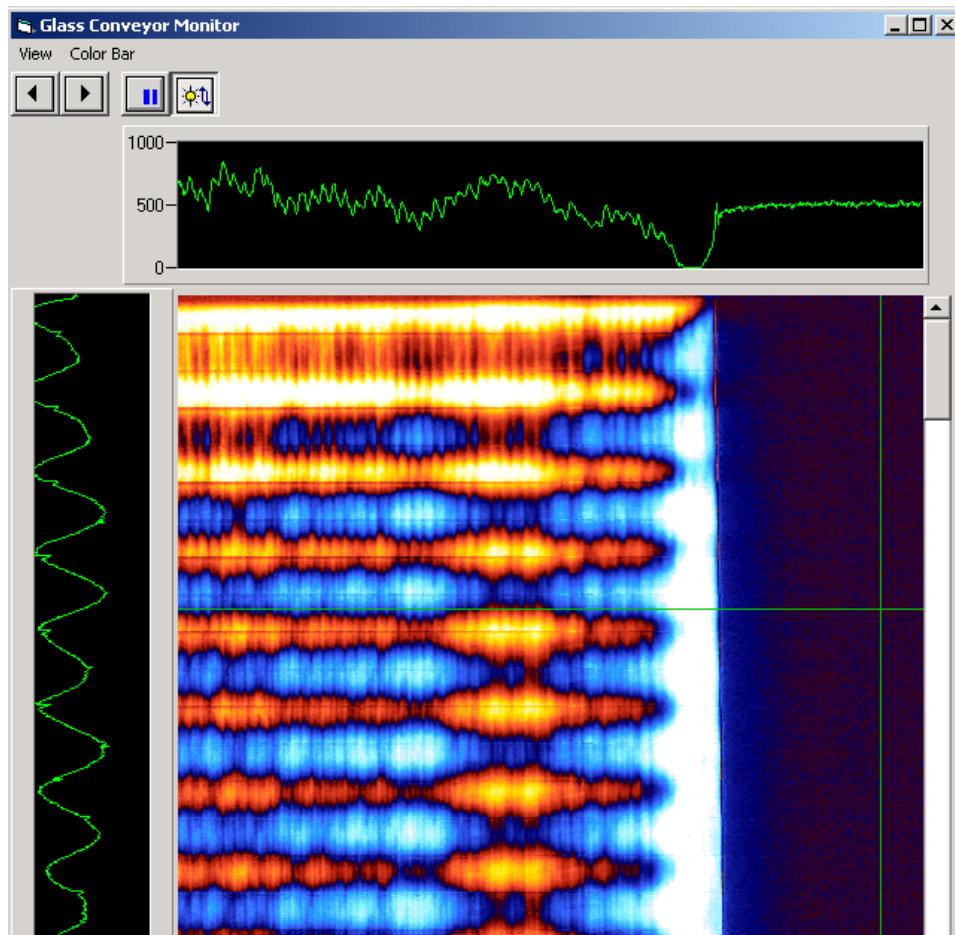
GFP2400m Camera



Illuminator Box

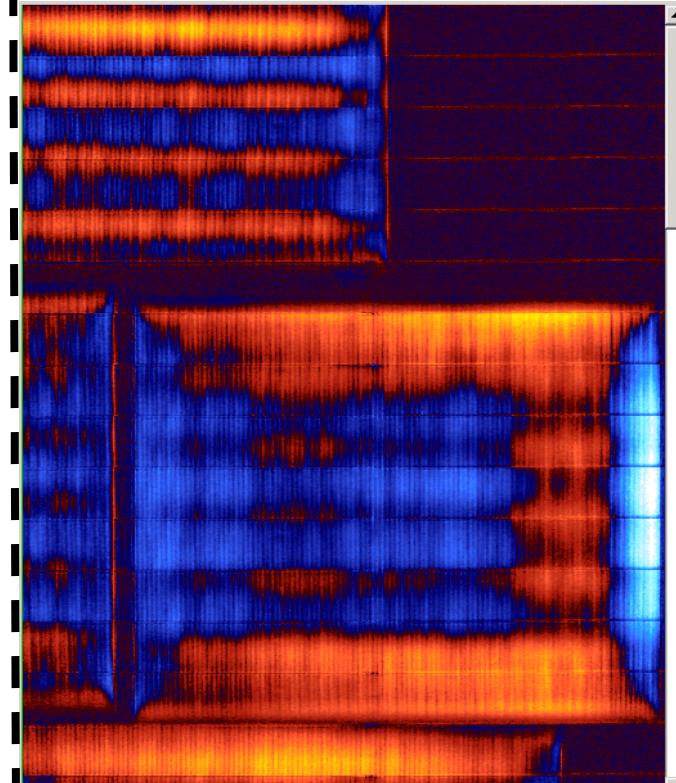


Roll Stress



This image collected with GFP 2000 Online. Also typical example of result
from GFP 1200 or GFP 2000

10. Heat Treating

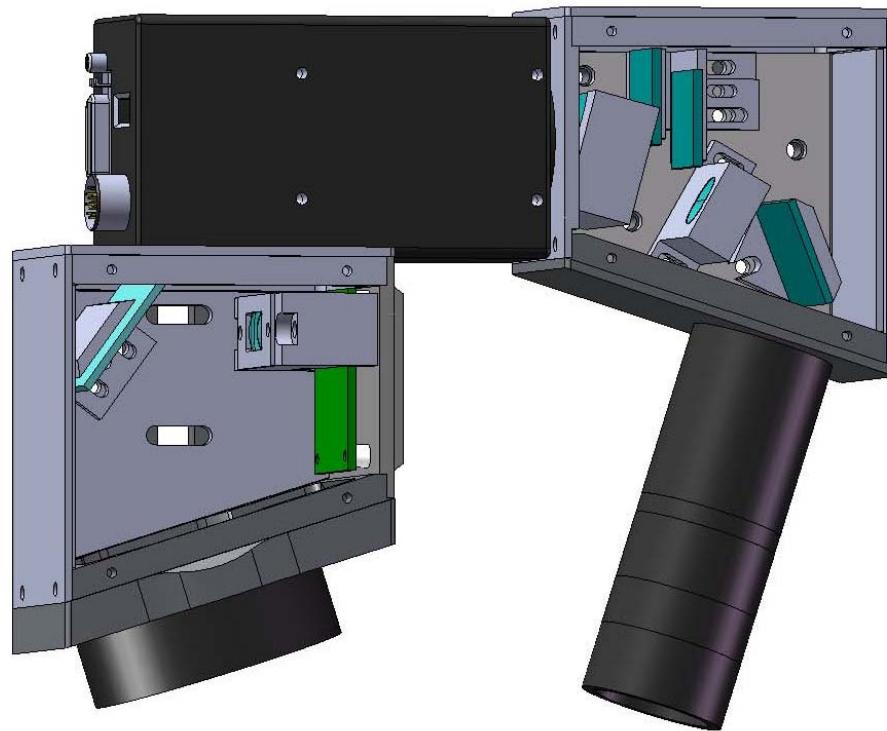


Center of conveyor

Far right

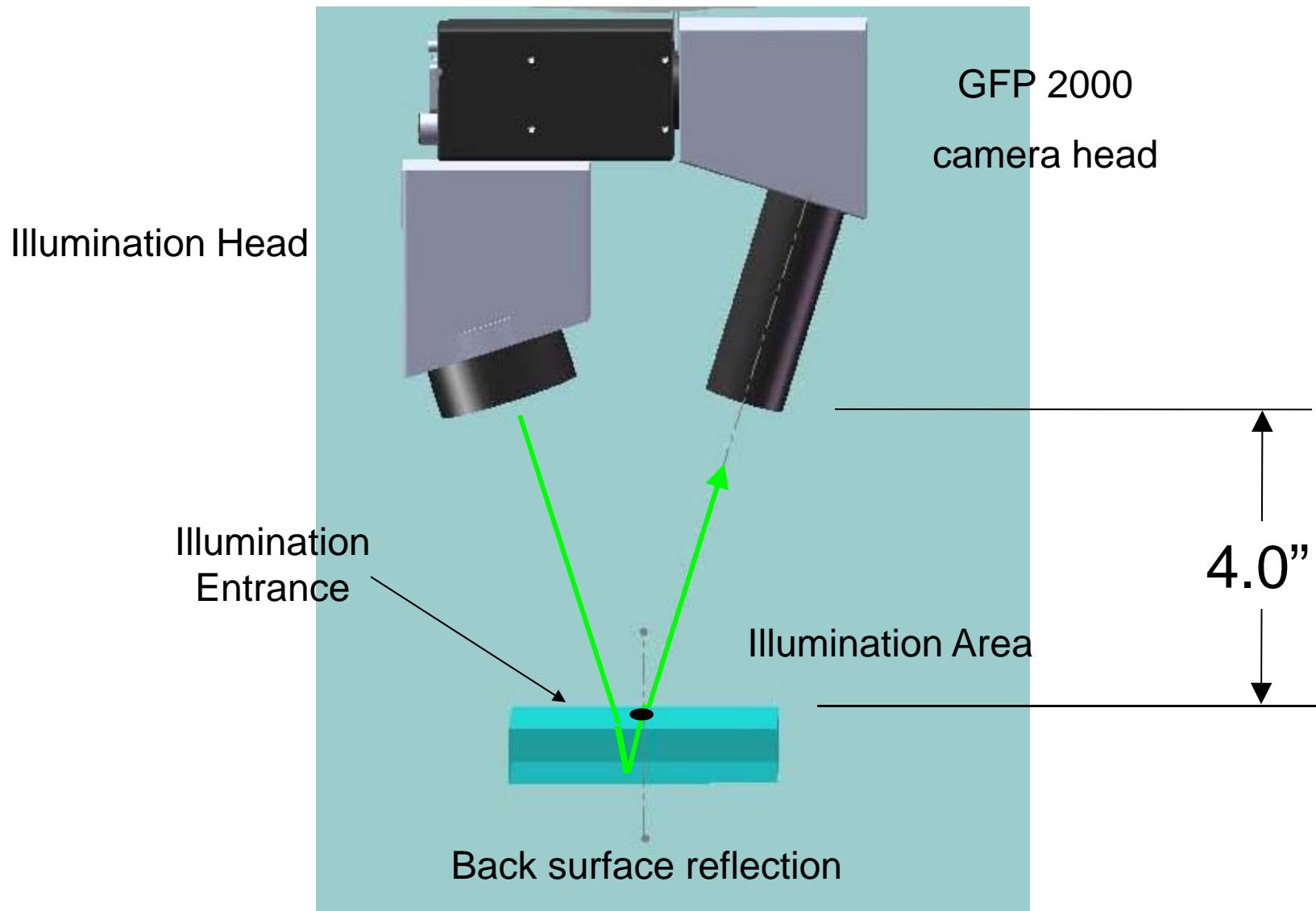
This image collected with GFP 2000 Online. Also typical example of result from GFP 1200 or GFP 2000

Orbiter Window Inspection System - Guts

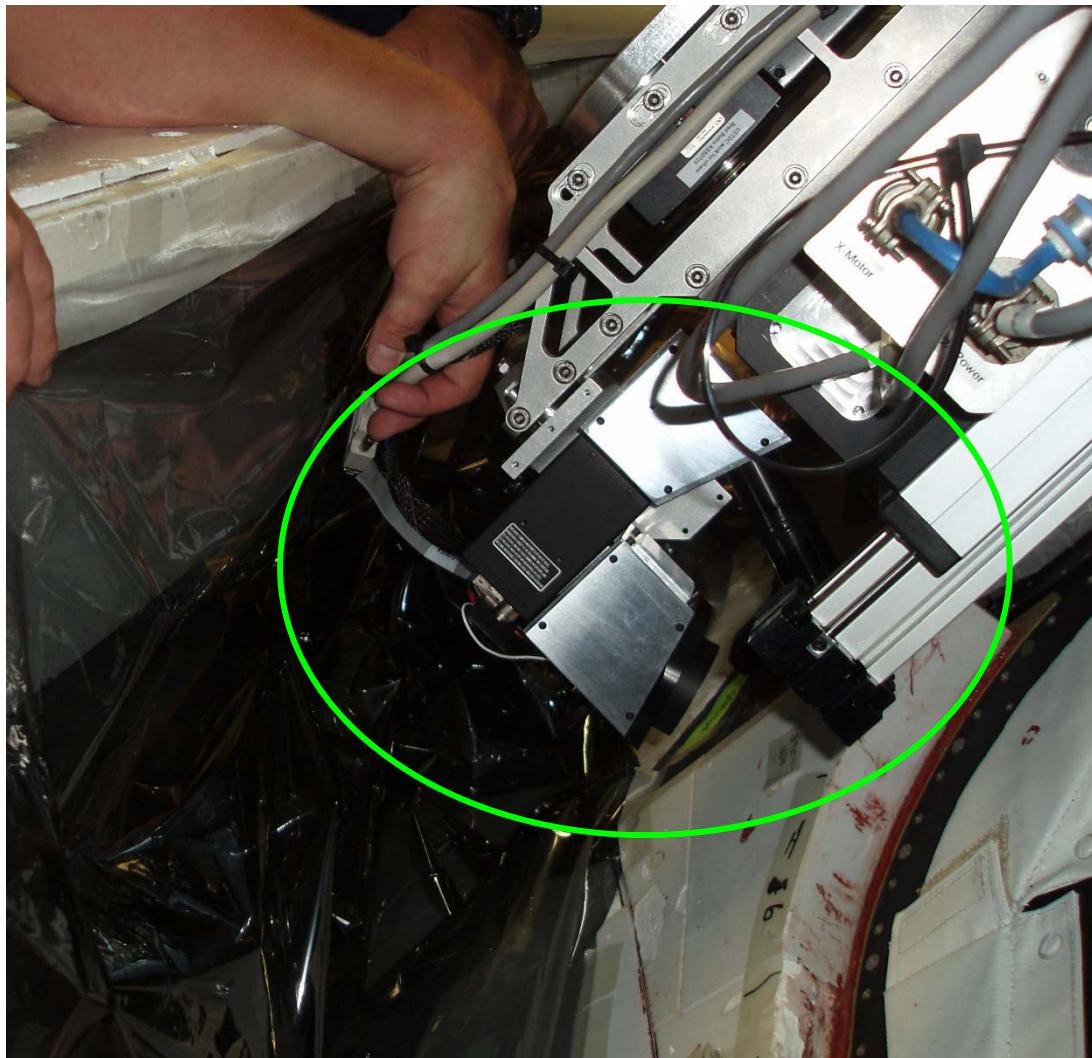


*Stress
Photonics*

Stress Photonics - Orbiter Window Inspection System



**Stress
Photonics**

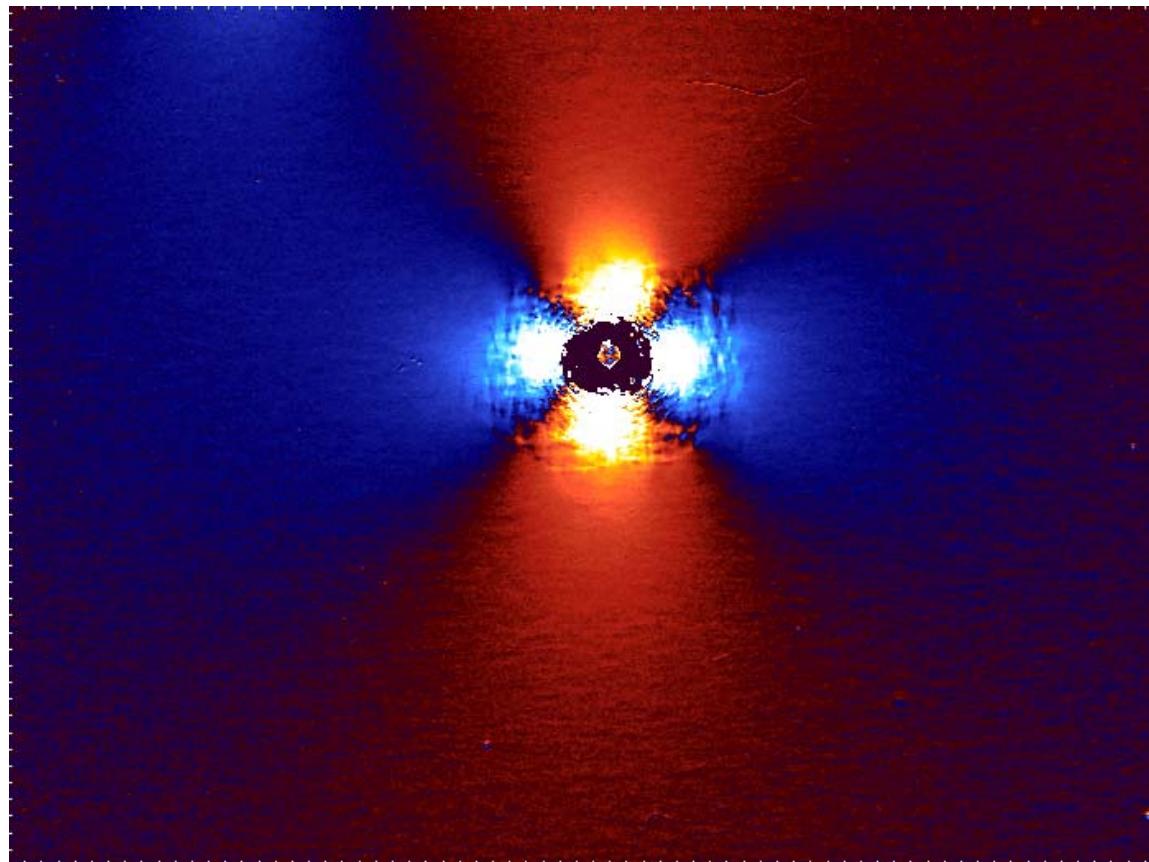


**Stress
Photonics**

Defect stress profiles

- HVI
- LVI / Digs
- Bruise
- Chatter Check

27-135-1 HVI

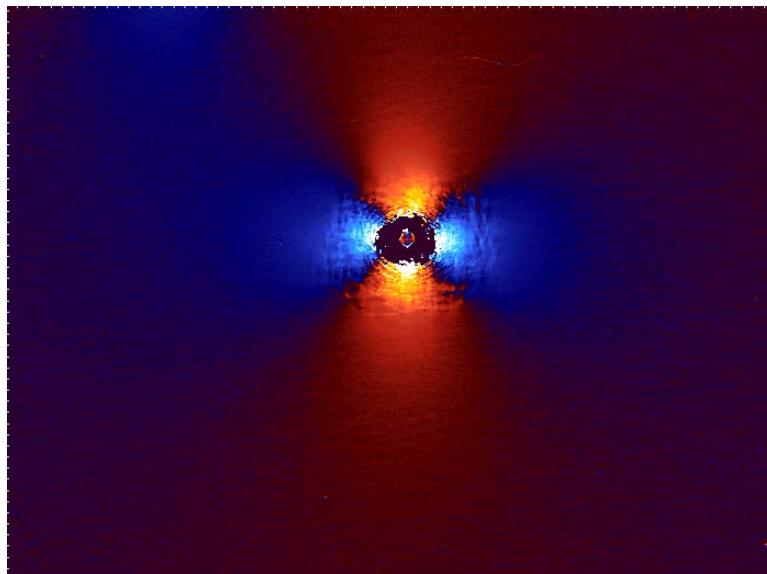


$\sigma_x - \sigma_y$

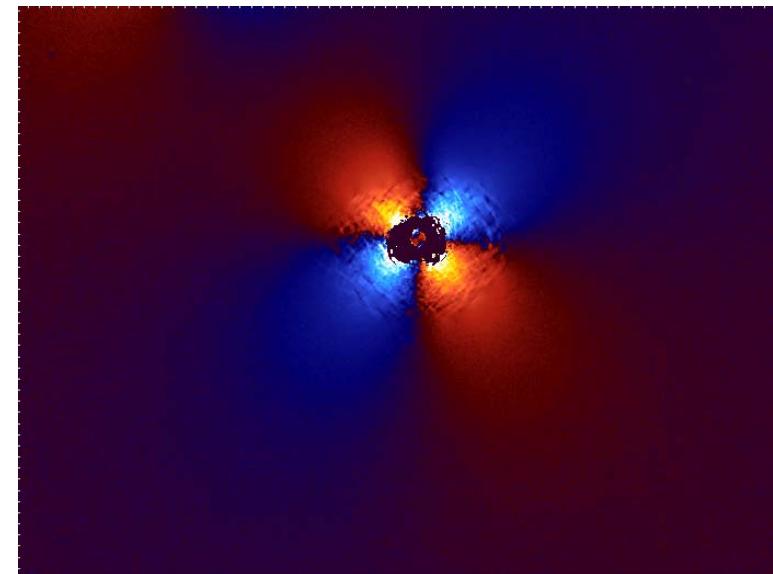
*Stress
Photonics*

GFP 2400 Stress data

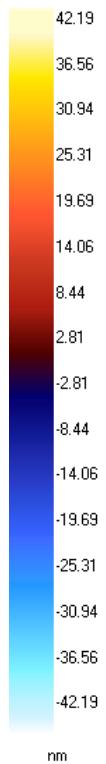
(captured and stored)



$$\sigma_x - \sigma_y$$



$$\sigma_{45} - \sigma_{-45}$$

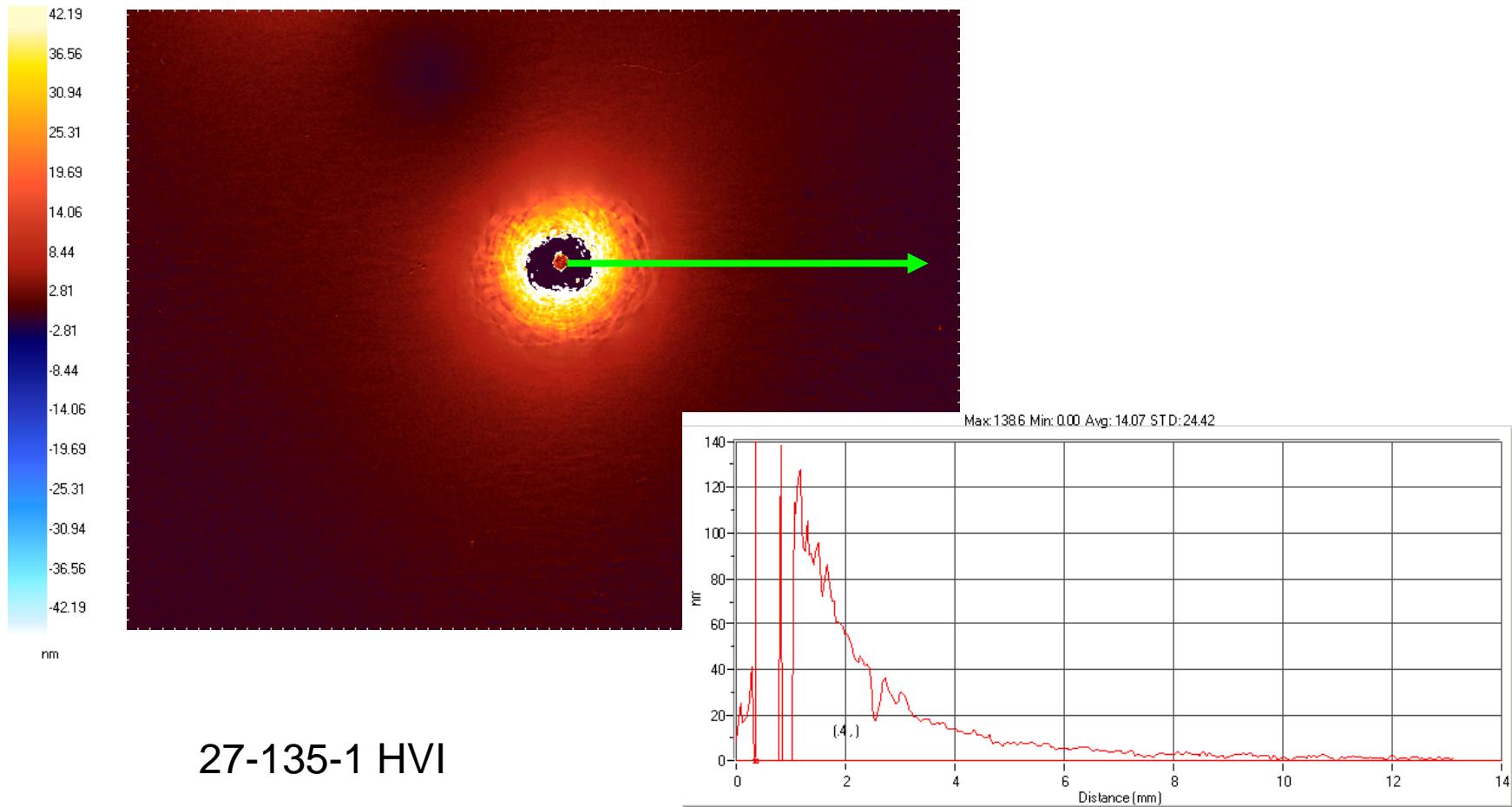


27-135-1 HVI

*Stress
Photonics*

Max in-plane shear ($\sigma_1 - \sigma_2$)

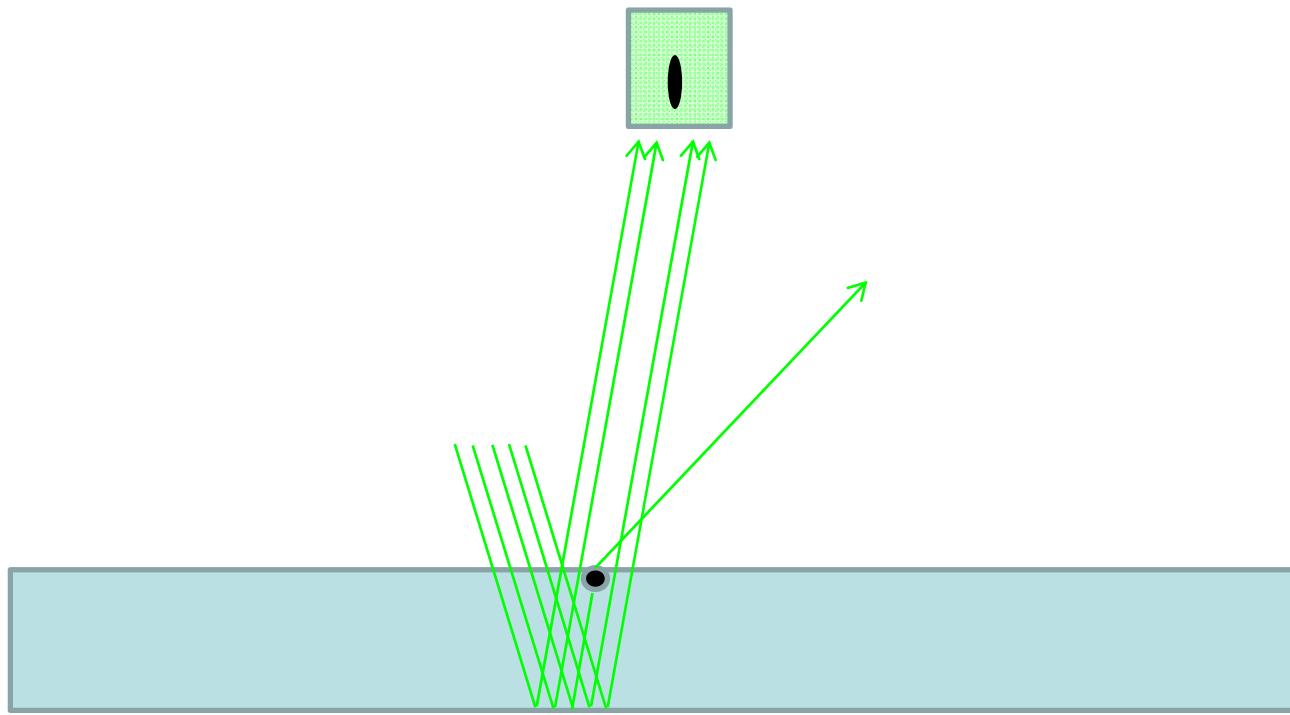
(Calculated)



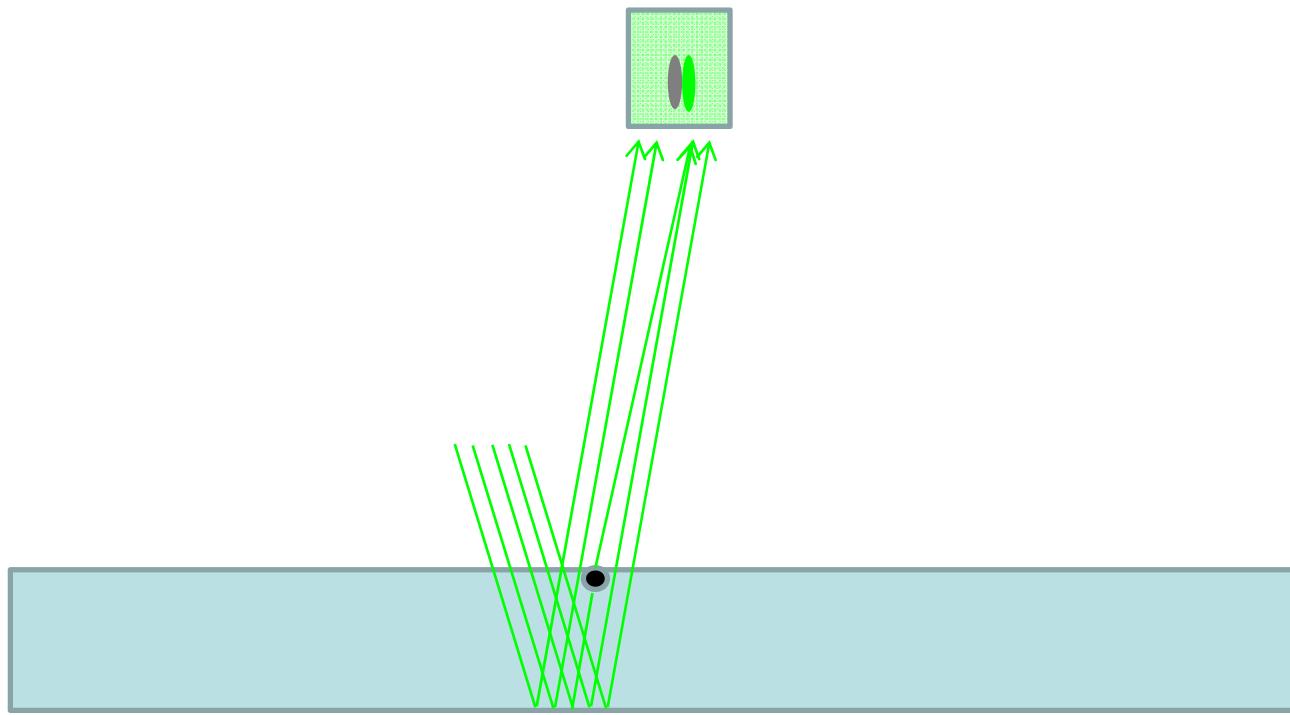
Modes of operation

- Stress
- Shadow
- Schlieren
- Refractive polarization

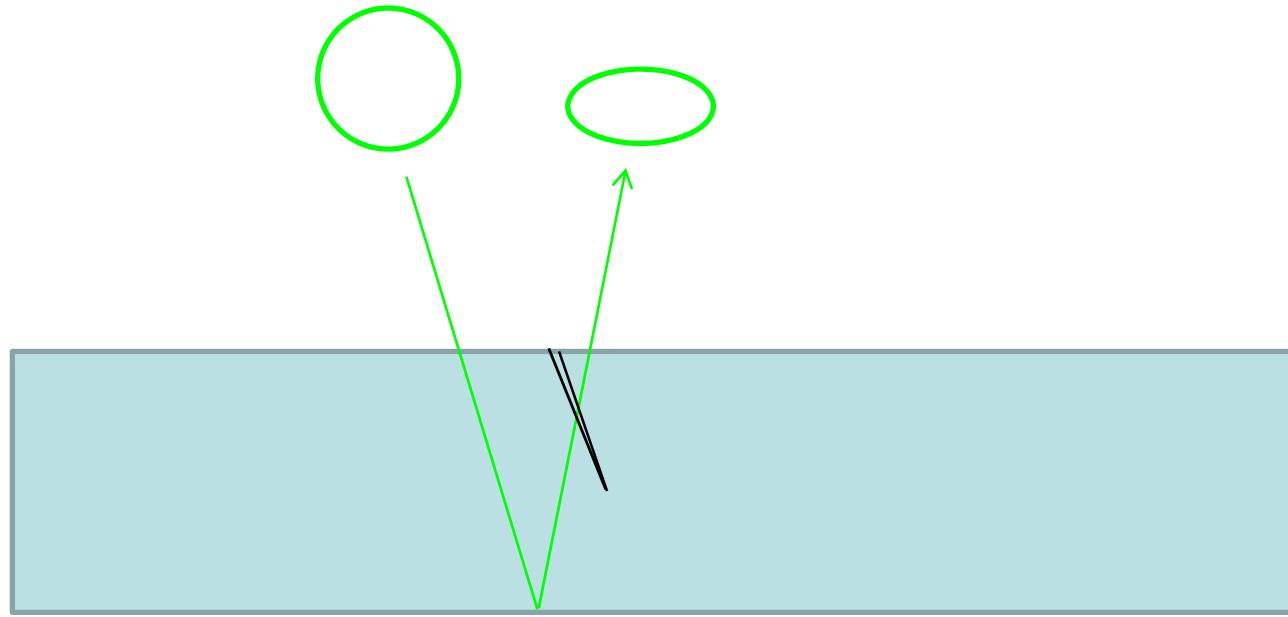
Shadow



Schlieren

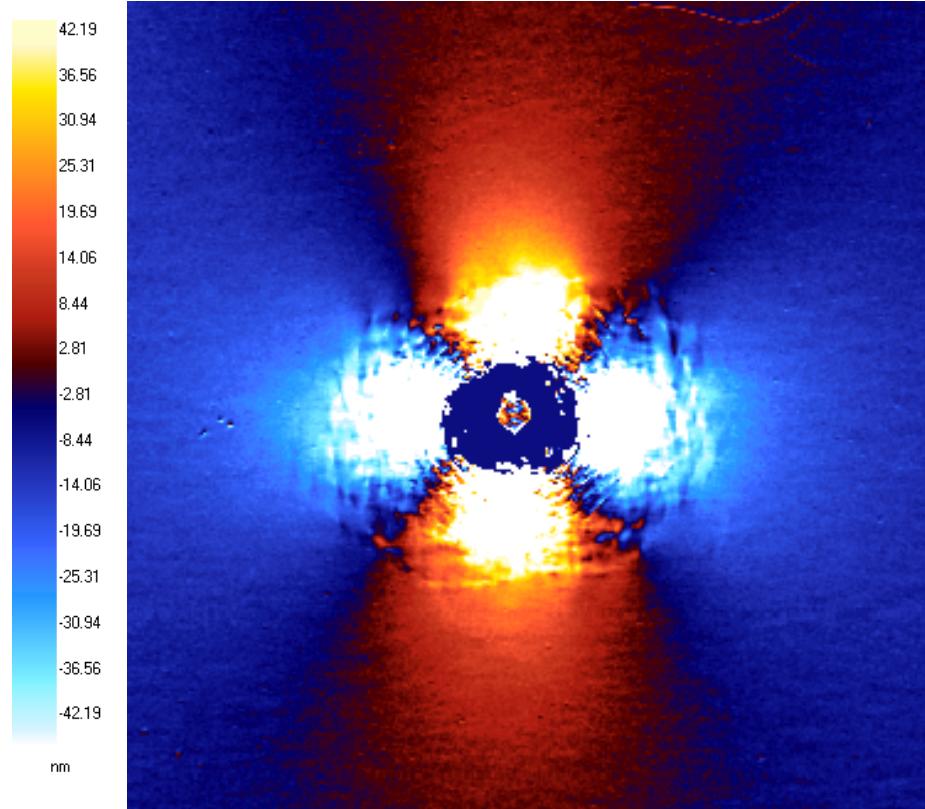


Refractive Polarization



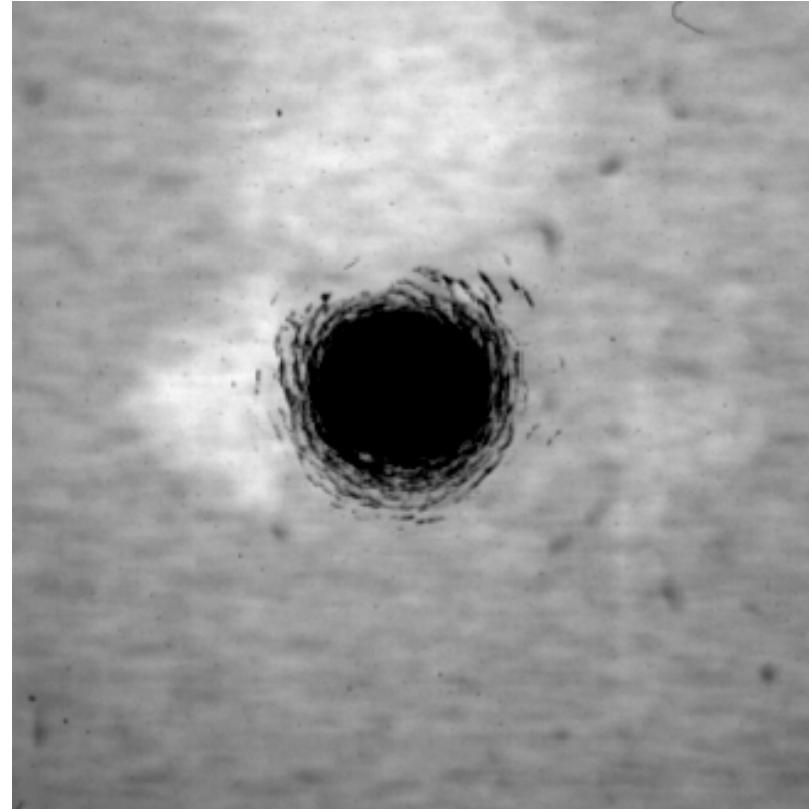
Shadow and Polarization match

HVI Stress Profile



$\sigma_x - \sigma_y$

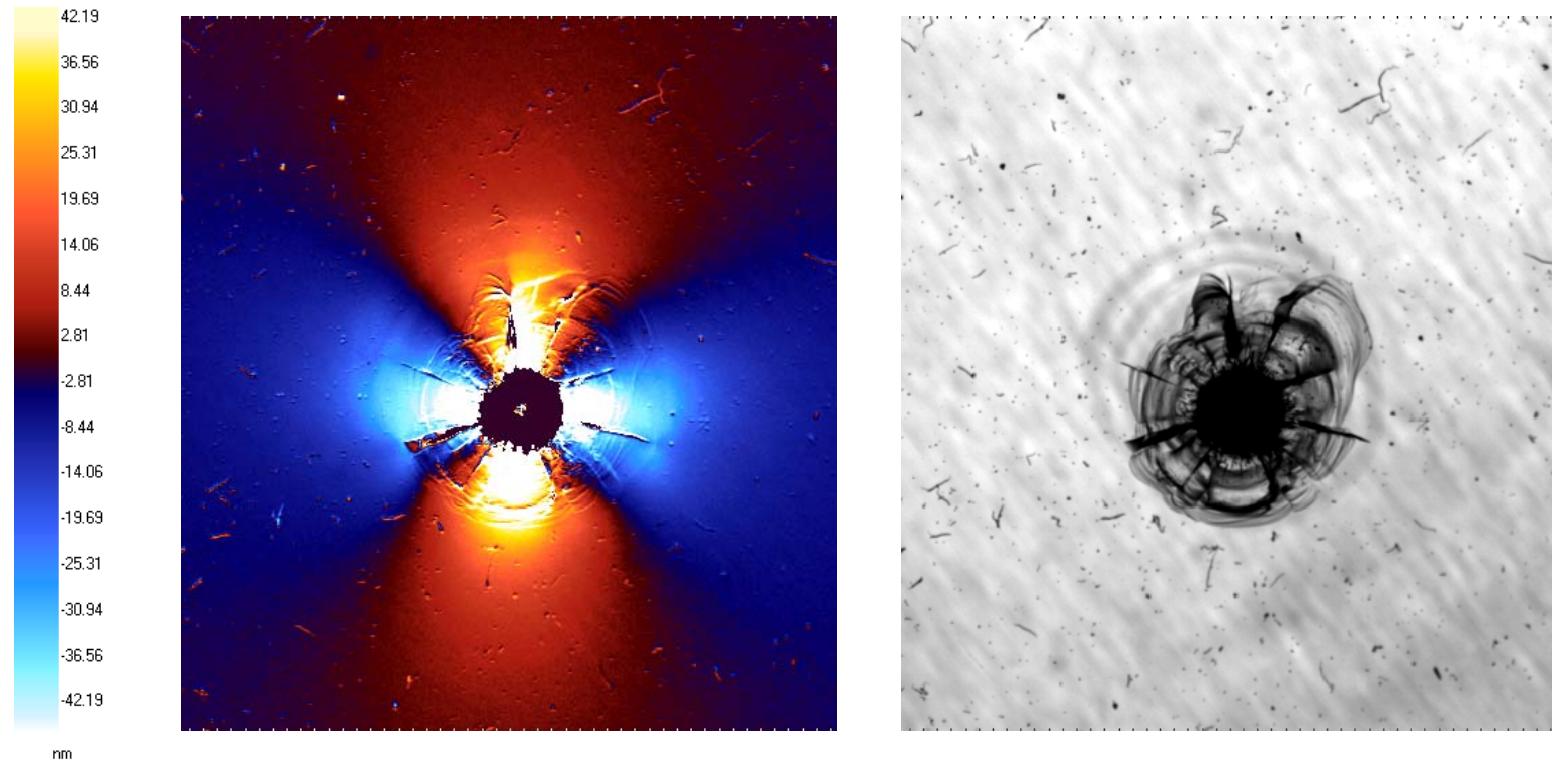
27-135-1 HVI



Light Image

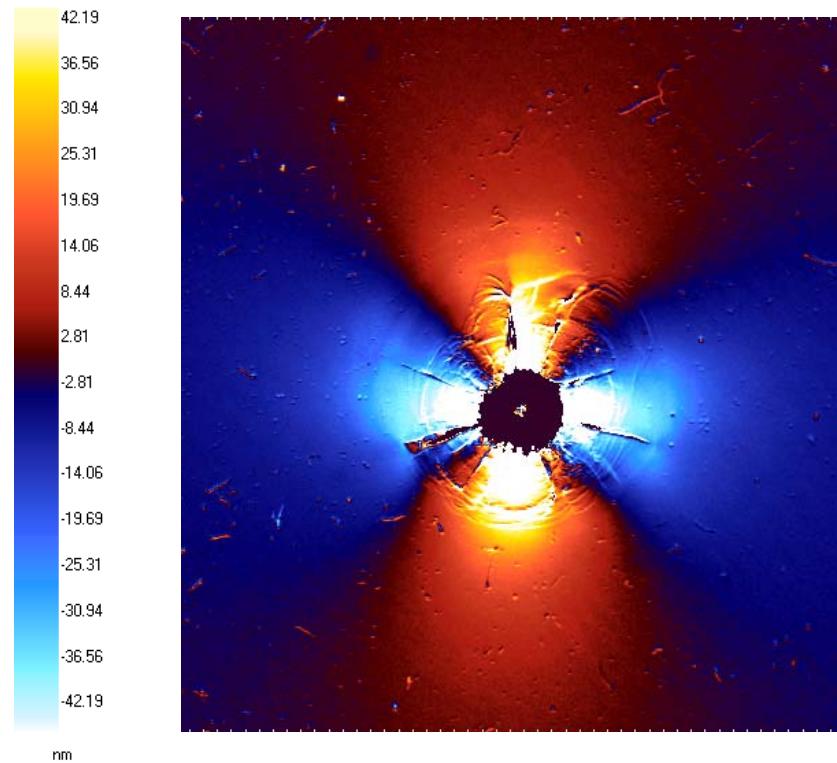
*Stress
Photonics*

Stress Fields



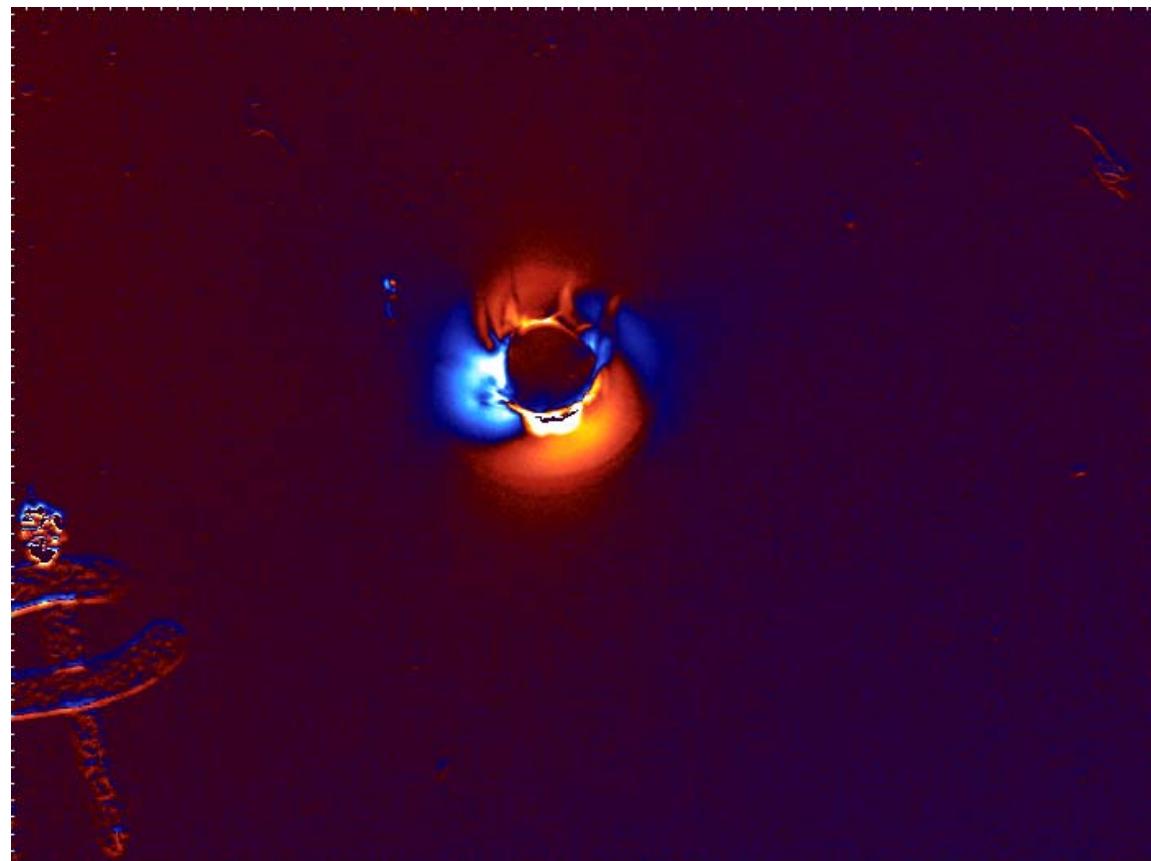
Stress Fields extend outside of shadow

HITF 05305



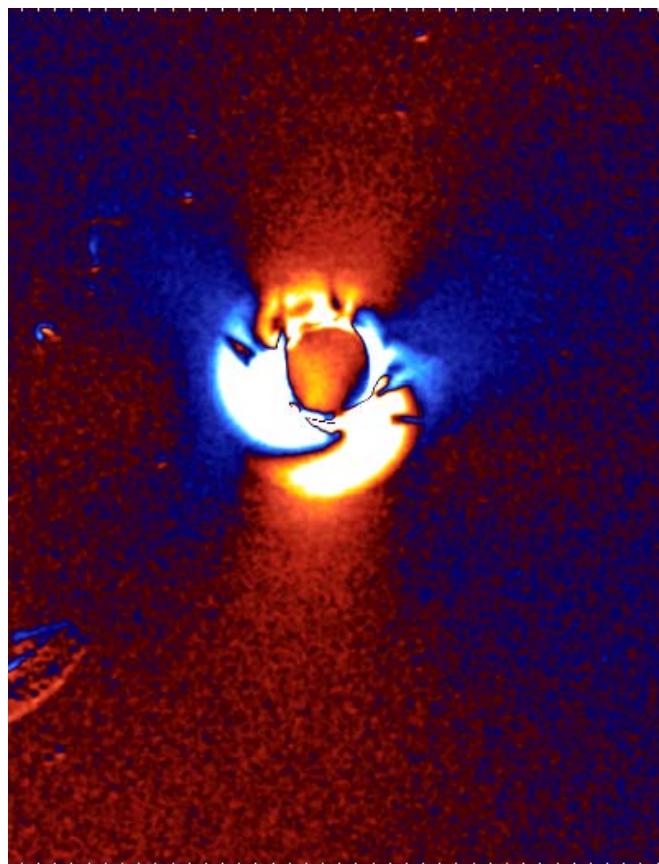
*Stress
Photonics*

27-139-18 Bruise



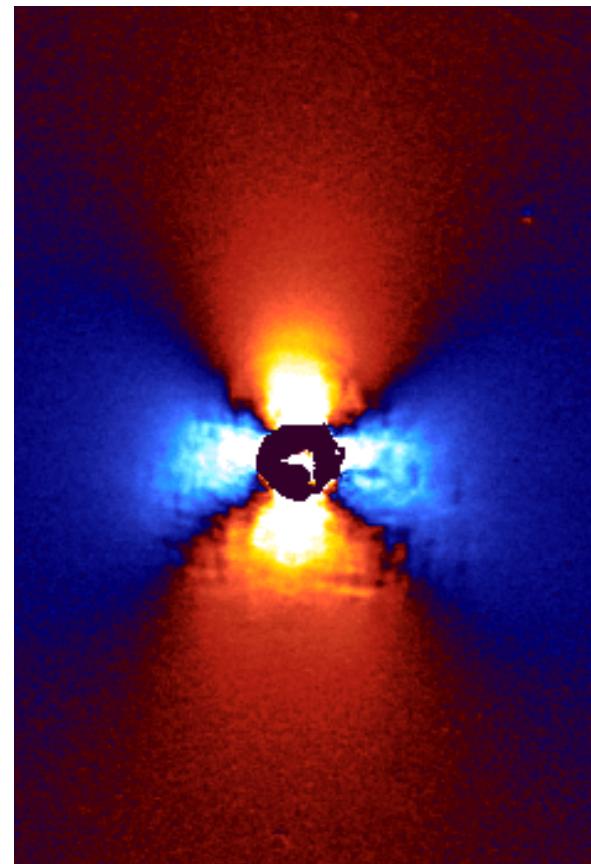
Stress Profile differentiation

Bruise



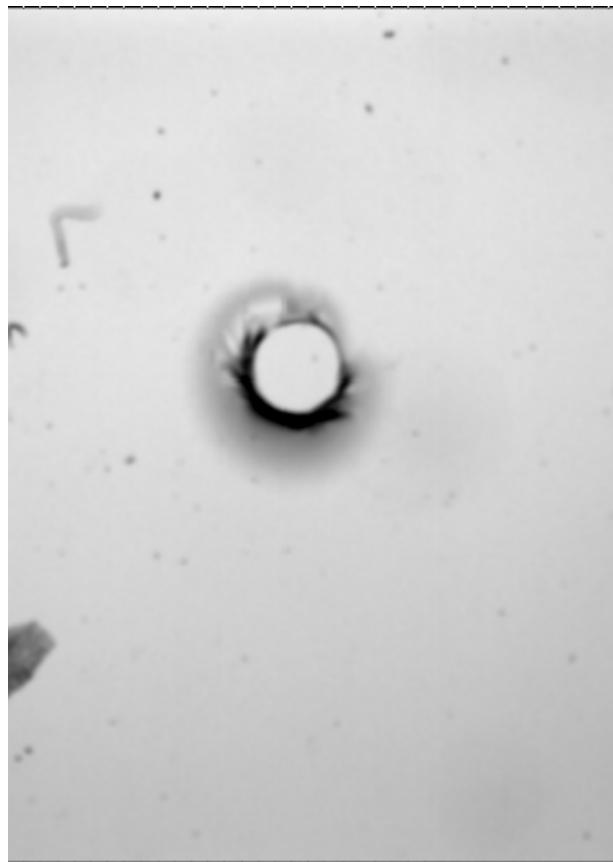
27-139-15

HVI



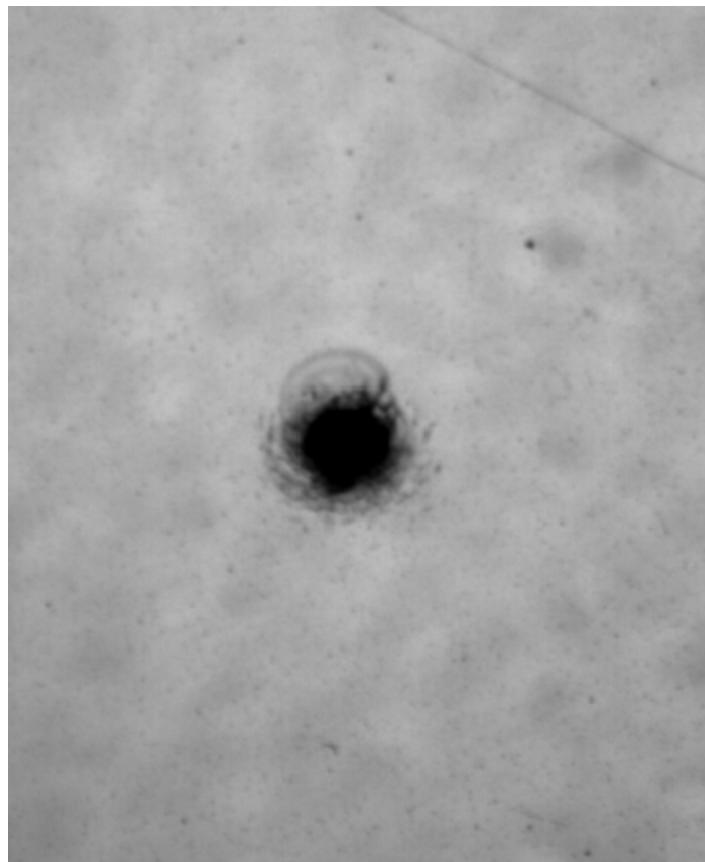
27-116-1

Bruise



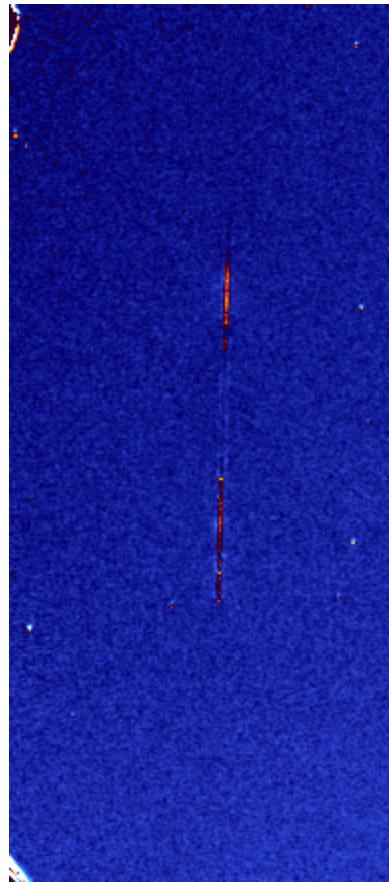
27-139-15

HVI

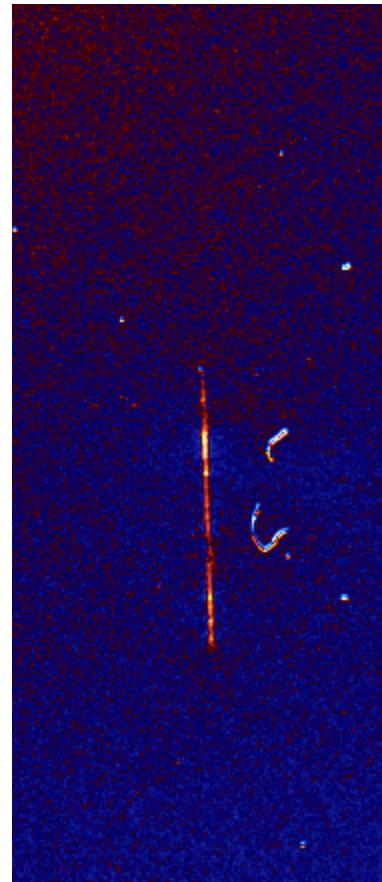


27-116-1

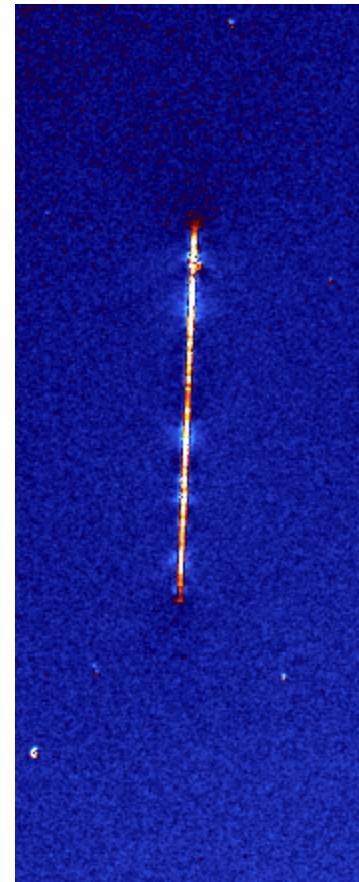
Chatter Checks



26-210-31



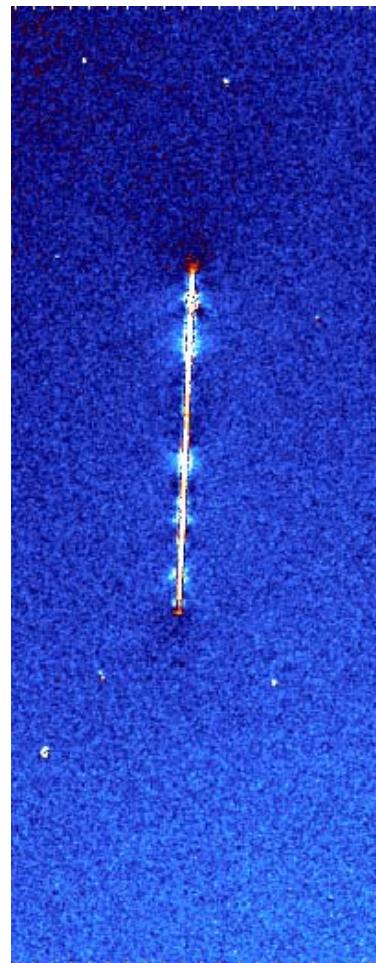
26-210-25



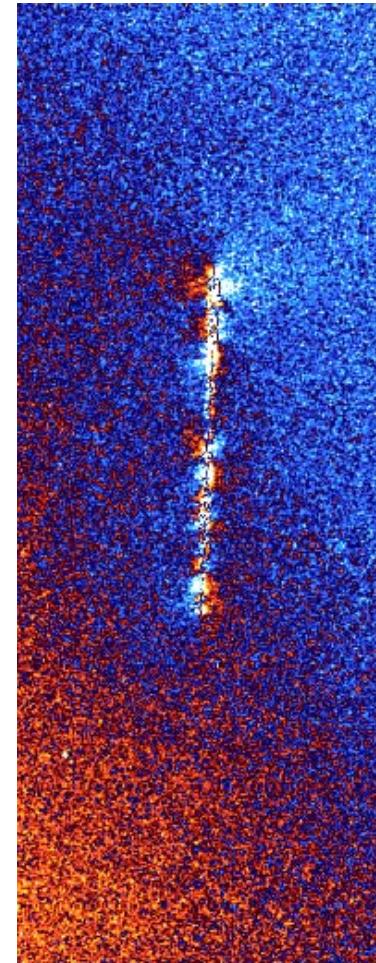
26-210-30



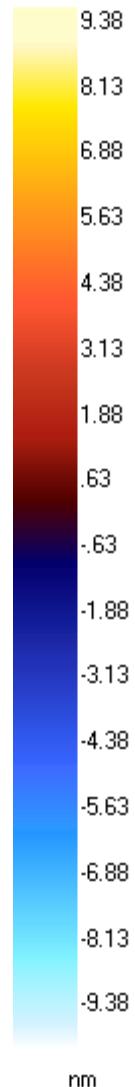
26-210-30 CC



$\sigma_x - \sigma_y$



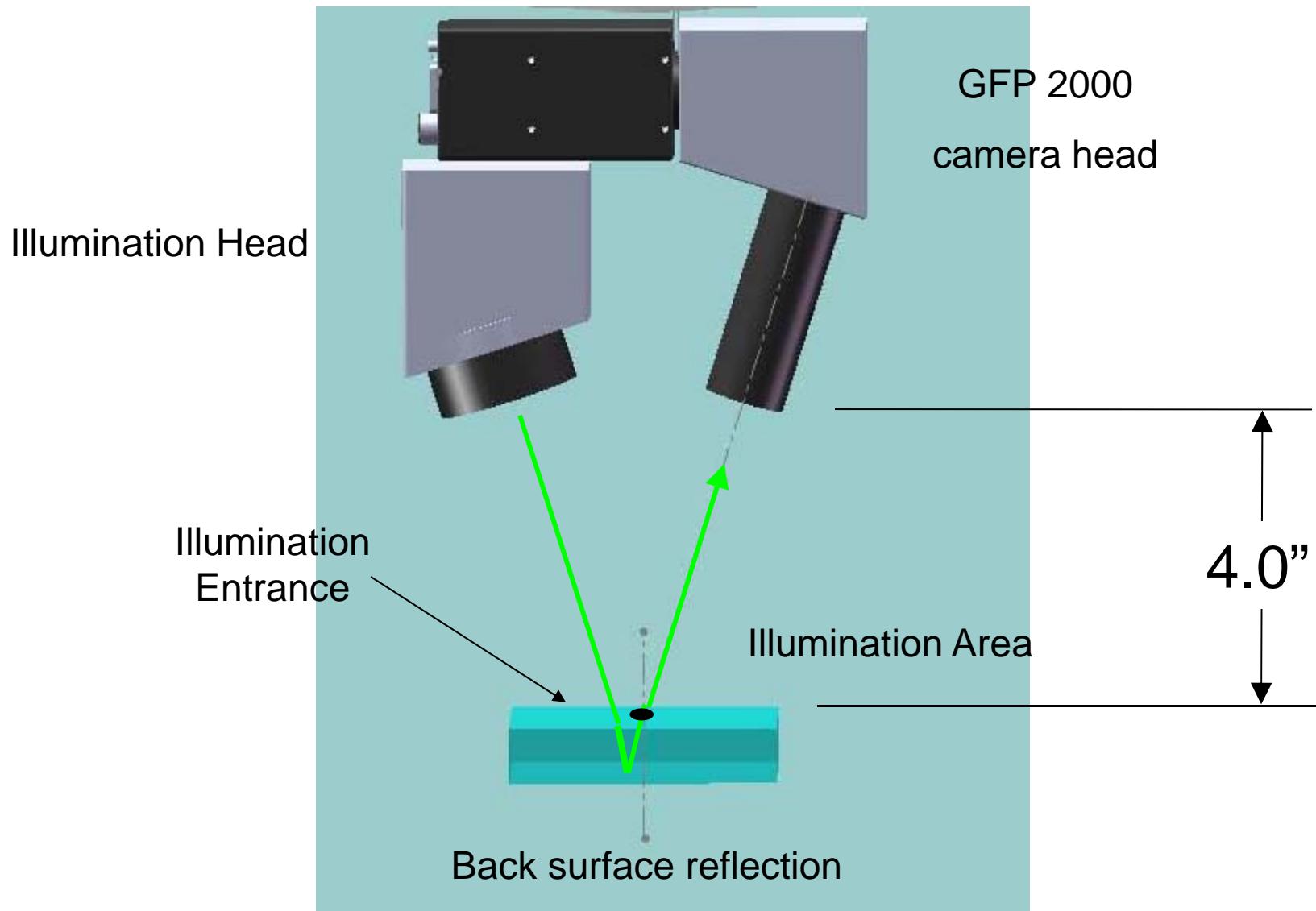
$\sigma_{45} - \sigma_{-45}$



nm

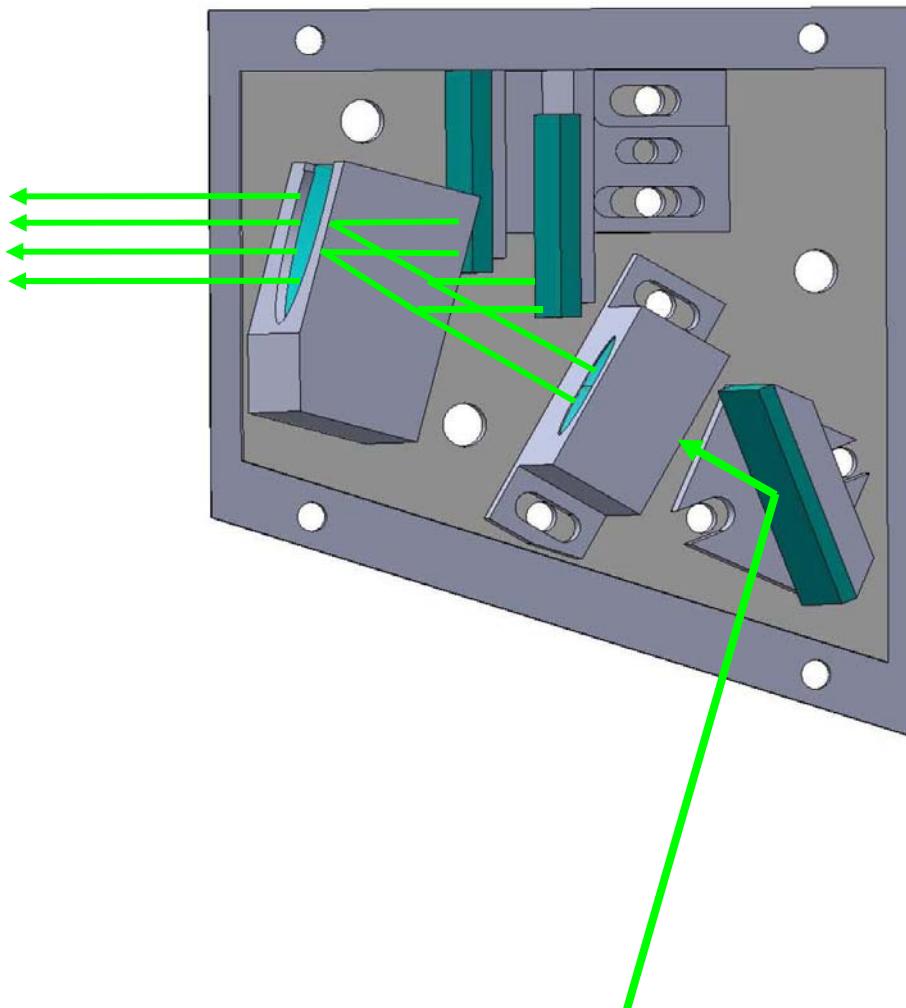
*Stress
Photonics*

Stress Photonics - Orbiter Window Inspection System



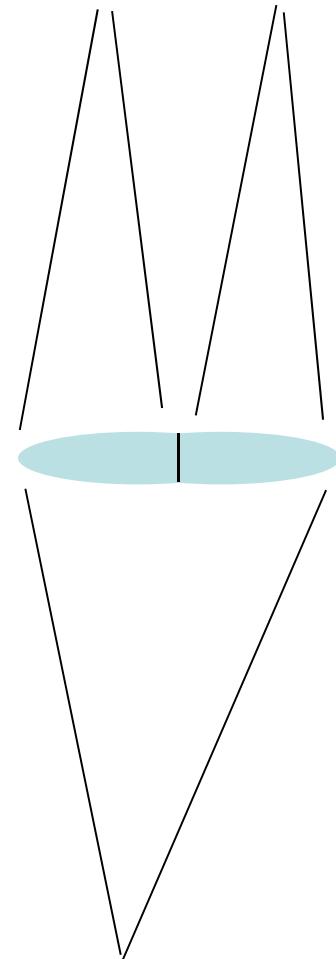
**Stress
Photonics**

Image Separation



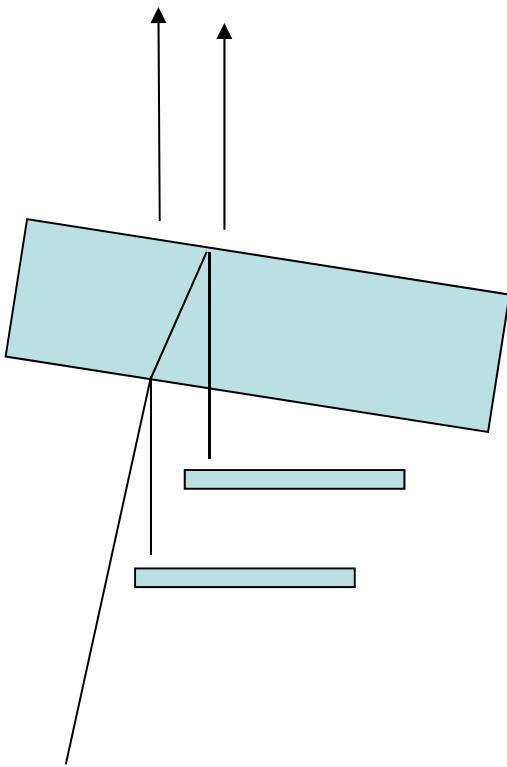
*Stress
Photonics*

Stereoscopic Copies

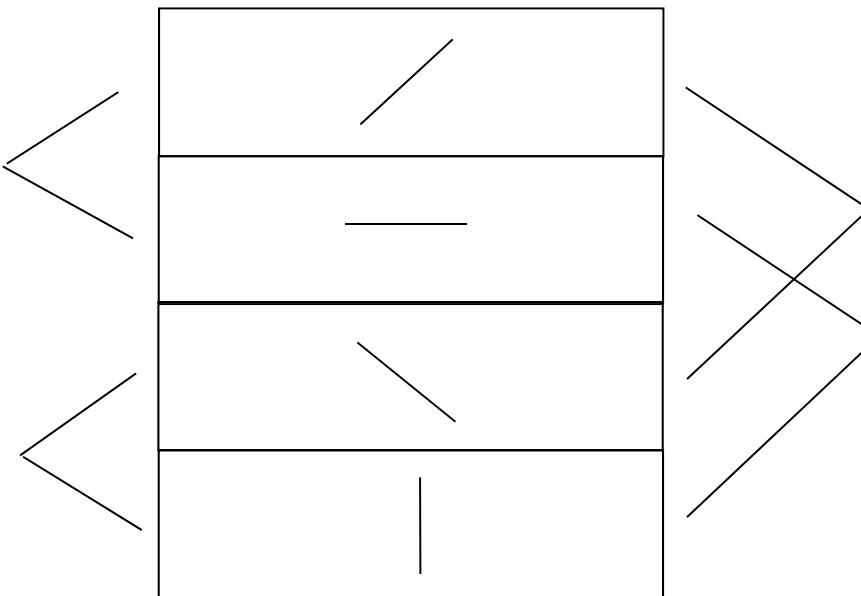


**Stress
Photonics**

Exact Copies



Stereoscopic
Copies



Exact
Copies

Assessment

- Automated
- Fast
- Very high detection
- Good defect differentiation

Qualifying remarks

- This primary goal of this method is to detect and identify types of defects.
- The geometric stress concentration and the service loads dictate failure, not the presence of residual stress in a parked state.